

10 MHz Precision Op Amps

Features

- Gain Bandwidth Product: 10 MHz (typical)
- Slew Rate: 15 V/ μ s (typical at $V_{DD} = 5.5V$)
- Total Harmonic Distortion (THD): -115 dBc (typical) at 1 kHz and 2 V_{P-P}
- Input Offset Voltage: $\pm 180 \mu V$ (maximum, $V_{CM} = 0.1V$)
- Rail-to-Rail: I/O
- Power Supply: 2.2V to 5.5V
 - Single or Dual (Split) Supplies
 - Quiescent Current: 720 μA /chan (typical)
- Enhanced EMI Protection:
 - EMIRR: 81 dB at 2.4 GHz (typical)
- Extended Temperature Range: $-40^{\circ}C$ to $+125^{\circ}C$

Typical Applications

- Automotive, see [Product Identification System \(Automotive\)](#)
- Audio
- Test and Measurement
- Communications
- Medical
- Active Filters
- Transimpedance Amplifiers
- Current Sensing
- ADC Driver
- DAC Buffer

Design Aids

- Analog Demonstration and Evaluation Boards
- Application Notes

Description

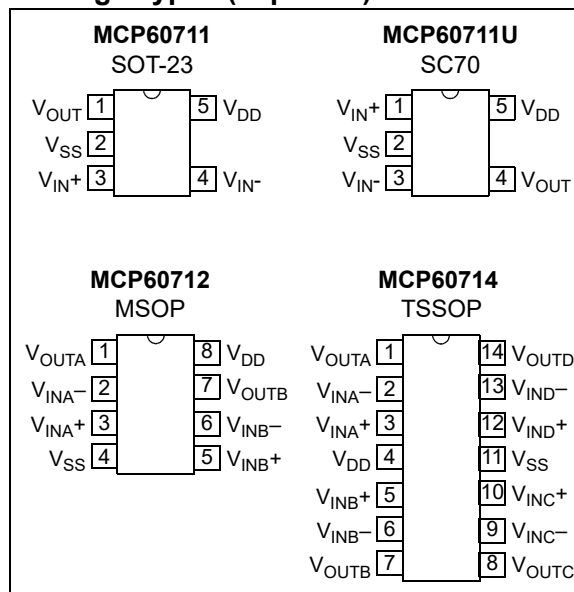
The MCP60711/1U/2/4 op amps operate on a power supply voltage between 2.2V and 5.5V, and over the E-Temp Temperature Range ($-40^{\circ}C$ to $+125^{\circ}C$). The input offset voltage is trimmed at $25^{\circ}C$ and $V_{DD} = 3.5V$.

Single op amps are offered in 5L SC70 and 5L SOT-23 packages. Dual op amps are in 8L MSOP packages. Quad op amps are in 14L TSSOP packages.

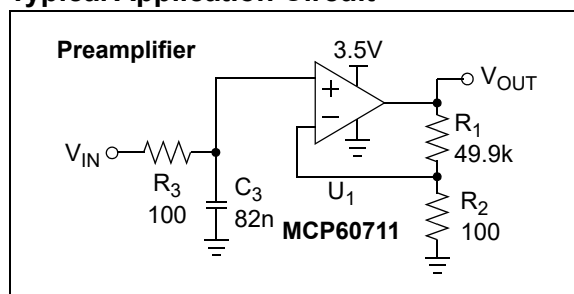
Related Op Amps

- MCP6051/2/4: 385 kHz, Low Input Offset Voltage
- MCP6061/2/4: 730 kHz, Low Input Offset Voltage
- MCP6071/2/4: 1.2 MHz, Low Input Offset Voltage
- MCP60811/1U/2/4: 25 MHz, Low Input Offset Voltage

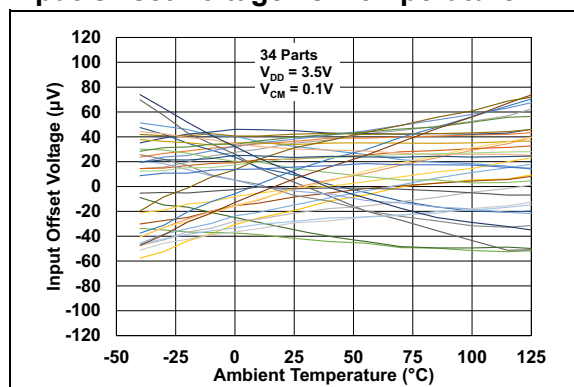
Package Types (Top View)



Typical Application Circuit



Input Offset Voltage vs. Temperature



MCP60711/1U/2/4

1.0 ELECTRICAL CHARACTERISTICS

1.1 Absolute Maximum Ratings †

$V_{DD} - V_{SS}$	-0.3V to +6.0V
Current at Input Pins	±2 mA
Inputs and Outputs	$V_{SS} - 0.5V$ to $V_{DD} + 0.5V$
Input Difference Voltage ($V_{IN+} - V_{IN-}$).....	(intermittent) $\pm V_{DD}$(continuous) ±50 mV
Output Short Circuit Current.....	±60 mA
Current at Output and Supply Pins.....	(continuous) ±30 mA
Storage Temperature.....	-65°C to +150°C
Maximum Junction Temperature	+150°C
ESD Protection (HBM, CDM)	≥ 4 kV, 2 kV

† **Notice:** Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not intended. Exposure to maximum rating conditions for extended periods may affect device reliability.

1.2 Specifications

TABLE 1-1: DC ELECTRICAL SPECIFICATIONS

Electrical Characteristics: Unless otherwise indicated, $T_A = 25^{\circ}\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$; see Figure 1-5 .						
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Input Offset Voltage						
Input Offset Voltage (Note 2)	V_{OS}	-180	± 60	180	μV	$V_{CM} = 0.1\text{V}$ (Note 3)
		-180	± 30	180		$V_{CM} = V_{DD} - 0.5\text{V}$ (Note 3)
Input Offset Linear Temp. Co.	TC_1	—	± 0.40	—	$\mu\text{V}/^{\circ}\text{C}$	$T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, $V_{CM} = 0.1\text{V}$
		—	± 0.45	—		$T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, $V_{CM} = V_{DD} - 0.5\text{V}$
Input Offset Quadratic Temp. Co.	TC_2	—	± 1.5	—	$\text{nV}/^{\circ}\text{C}^2$	$T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, $V_{CM} = 0.1\text{V}$
		—	± 2.1	—		$T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, $V_{CM} = V_{DD} - 0.5\text{V}$
Power Supply Rejection Ratio	PSRR	80	95	—	dB	$V_{DD} = 2.2\text{V}$ to 5.5V , $V_{CM} = 0.1\text{V}$
		76	92	—		$V_{DD} = 2.2\text{V}$ to 5.5V , $V_{CM} = V_{DD} - 0.5\text{V}$
Input Current and Impedance						
Input Bias Current	I_B	-20	± 0.1	20	pA	$V_{DD} = 5.5\text{V}$, $V_{CM} = 2.75\text{V}$, $T_A = +25^{\circ}\text{C}$
		—	± 1	—		$V_{DD} = 5.5\text{V}$, $V_{CM} = 2.75\text{V}$, $T_A = +85^{\circ}\text{C}$
		—	120	—		$V_{DD} = 5.5\text{V}$, $V_{CM} = 2.75\text{V}$, $T_A = +125^{\circ}\text{C}$
Input Offset Current	I_{OS}	-20	± 0.1	20		$V_{DD} = 5.5\text{V}$, $V_{CM} = 2.75\text{V}$, $T_A = +25^{\circ}\text{C}$
		—	± 0.3	—		$V_{DD} = 5.5\text{V}$, $V_{CM} = 2.75\text{V}$, $T_A = +85^{\circ}\text{C}$
		-400	± 6	400		$V_{DD} = 5.5\text{V}$, $V_{CM} = 2.75\text{V}$, $T_A = +125^{\circ}\text{C}$
Common Mode Input Impedance	Z_{CM}	—	$10^{11} 6.5$	—	ΩpF	
Differential Mode Input Impedance	Z_{DM}	—	$10^{11} 2.4$	—		

- Note** 1: V_{CML} , V_{CMH} , V_{OL} and V_{OH} change with temperature; see [Figure 2-21](#) and [Figure 2-23](#).
2: The Rev. A data sheet's V_{OS} and ΔV_{OS} specs apply to parts manufactured before January 2026.
3: V_{OS} is trimmed in production. This spec includes aging (for a typical use case). It is set by characterization and design only; it is not tested in production.

TABLE 1-1: DC ELECTRICAL SPECIFICATIONS (CONTINUED)

Electrical Characteristics: Unless otherwise indicated, T _A = 25°C, V _{DD} = 3.5V, V _{SS} = GND, V _{CM} = 0.1V, V _{OUT} = V _{DD} /2, V _L = V _{DD} /2, R _L = 5 kΩ to V _L and C _L = 30 pF; see Figure 1-5 .						
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Input Common Mode Voltage						
Common Mode Voltage Range (Note 1)	V _{CML}	—	-0.4	-0.3	V	T _A = 25°C
	V _{CMH}	V _{DD} + 0.3	V _{DD} + 0.4	—		T _A = 25°C
Common Mode Rejection Ratio	CMRR	80	95	—	dB	V _{CM} = -0.3V to V _{DD} + 0.3V
Open-Loop Gain						
DC Open-Loop Gain	A _{OL}	97	112	—	μV/V	V _{OUT} = 0.2V to V _{DD} – 0.2V, V _{CM} = 0.1V
		97	112	—		V _{OUT} = 0.2V to V _{DD} – 0.2V, V _{CM} = V _{DD} – 0.5V
Output						
Output Voltage Swing – Low (Note 1)	V _{OL} – V _{SS}	—	5	—	mV	Input Overdrive = -0.5V, V _{DD} = 2.2V
		—	8	—		Input Overdrive = -0.5V, V _{DD} = 5.5V
		10	45	200		Input Overdrive = -0.5V, V _{DD} = 5.5V, R _L = 500Ω
Output Voltage Swing – High (Note 1)	V _{OH} – V _{DD}	—	-4	—		Input Overdrive = +0.5V, V _{DD} = 2.2V
		—	-7	—		Input Overdrive = +0.5V, V _{DD} = 5.5V
		-180	-40	-10		Input Overdrive = +0.5V, V _{DD} = 5.5V, R _L = 500Ω
Output Short Circuit Current	I _{SCP}	—	12	—	mA	V _{DD} = 2.2V
		—	47	—		V _{DD} = 5.5V
	I _{SCM}	—	-18	—		V _{DD} = 2.2V
		—	-57	—		V _{DD} = 5.5V
Power Supply						
Supply Voltage	V _{DD}	2.2	—	5.5	V	
Quiescent Current per Amplifier	I _Q	0.65	0.72	0.79	mA	I _O = 0, t > t _{PON_TR}
Power-up Quiescent Current per Amplifier	I _{Q_TR}	—	1.5	—		I _O = 0, t _{PON} < t < t _{PON_TR} , Singles
		—	1.7	—		I _O = 0, t _{PON} < t < t _{PON_TR} , Duals and Quads
POR Trip Voltages	V _{PRHL}	1.45	1.61	—	V	POR turns off (V _{DD} ↓), V _L = 0V, not tested in production
	V _{PRLH}	—	1.76	1.95		POR turns on (V _{DD} ↑), V _L = 0V, not tested in production
POR Trip Voltage Drift with Temperature	ΔV _{PRHL} /ΔT _A	—	0.90	—	mV/°C	
	ΔV _{PRLH} /ΔT _A	—	0.85	—		

Note 1: V_{CML} , V_{CMH} , V_{OL} and V_{OH} change with temperature; see [Figure 2-21](#) and [Figure 2-23](#).

Note 2: The Rev. A data sheet's V_{OS} and ΔV_{OS} specs apply to parts manufactured before January 2026.

Note 3: V_{OS} is trimmed in production. This spec includes aging (for a typical use case). It is set by characterization and design only; it is not tested in production.

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TABLE 1-2: AC ELECTRICAL SPECIFICATIONS

Electrical Characteristics: Unless otherwise indicated, T _A = 25°C, V _{DD} = 3.5V, V _{SS} = GND, V _{CM} = 0.1V, V _{OUT} = V _{DD} /2, V _L = V _{DD} /2, R _L = 5 kΩ to V _L and C _L = 30 pF; see Figure 1-6 .						
Parameters	Sym.	Min.	Typ	Max.	Units	Conditions
AC Response						
Gain-Bandwidth Product	GBWP	—	10	—	MHz	V _{OUT} = 0.1 V _{P-P} , G _N > +2
Full Power Bandwidth	FPBW	—	1.1	—		V _{DD} = 5V, V _{CM} = 2.5V, V _{OUT} = 4.6 V _{P-P} , Gain = -1 V/V
Phase Margin	PM	—	65	—	°	G = +1, V _{OUT} = 0.1 V _{P-P}
		—	45	—		G = +1, V _{OUT} = 0.1 V _{P-P} , C _L = 100 pF
Step Response						
Settling Time	t _{settle}	—	110	—	ns	G = +1, V _{CM} = 0.5V, +0.1V step and 1% settling
		—	110	—		G = +1, V _{CM} = V _{DD} – 0.5V, +0.1V step and 1% settling
Slew Rate	SR	—	4.1	—	V/μs	G = +1, V _{DD} = 2.2V
		—	15	—		G = +1, V _{DD} = 5.5V
Output Overdrive Recovery Time (Note 1)	t _{ODR}	—	0.9	—	μs	G = -10, V _{DD} = 3.5V, V _{CM} = V _{DD} /2, ±0.5V output overdrive (V _{IN} = V _{CM} ± 0.225V to V _{CM}); 90% of V _{OUT} change
Noise						
Input Noise Voltage	E _{ni}	—	3.1	—	μV _{P-P}	f = 0.1 Hz to 10 Hz, V _{CM} = 0.1V
		—	5.9	—		f = 0.1 Hz to 10 Hz, V _{CM} = V _{DD} – 0.5V
Input Noise Voltage Density	e _{ni}	—	5.4	—	nV/√Hz	f = 100 kHz, V _{CM} = 0.1V
		—	6.1	—		f = 100 kHz, V _{CM} = V _{DD} – 0.5V
Input Current Noise Density	i _{ni}	—	0.6	—	fA/√Hz	f = 1 kHz, V _{CM} = 0.1V
		—	0.6	—		f = 1 kHz, V _{CM} = V _{DD} – 0.5V
Harmonic Distortion – Output Nonlinearity						
Total Harmonic Distortion + Noise	THD+N	—	-115	—	dBc	G _N = 1 V/V, f = 1 kHz, V _{OUT} = 2 V _{P-P} , V _{DD} = 5V, V _{CM} = 2V
EMI Protection						
EMI Rejection Ratio	EMIRR	—	29	—	dB	V _{IN} = 0.1 V _{PK} , f = 400 MHz
		—	50	—		V _{IN} = 0.1 V _{PK} , f = 900 MHz
		—	71	—		V _{IN} = 0.1 V _{PK} , f = 1800 MHz
		—	81	—		V _{IN} = 0.1 V _{PK} , f = 2400 MHz
		—	112	—		V _{IN} = 0.1 V _{PK} , f = 6000 MHz

Note 1: t_{ODR} includes some uncertainty due to clock edge timing.

TABLE 1-2: AC ELECTRICAL SPECIFICATIONS (CONTINUED)

Electrical Characteristics: Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$; see Figure 1-6 .						
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Power Up/Down						
POR Off Time	t_{PRHL}	—	1	—	μs	$V_L = 0\text{V}$, $V_{DD} = 3.5\text{V}$ to 0V step, $G = 1$, $V_{CM} = 0.2\text{V}$, 90% of V_{OUT} change
POR On Time	t_{PRLH}	—	1	—		$V_L = 0\text{V}$, $V_{DD} = 0\text{V}$ to 3.5V step, $G = 1$, $V_{CM} = 0.2\text{V}$, 90% of V_{OUT} change
V_{OUT} Power On Time ($V_{DD} \uparrow$)	t_{PON}	—	22	—		$V_{DD} = 0\text{V}$ to 3.5V , $V_{CM} = 0.2\text{V}$, $V_L = 0\text{V}$, $G = 1$, 90% of V_{OUT} change
		—	52	—		$V_{DD} = 0\text{V}$ to 3.5V , $V_{CM} = 0.2\text{V}$, $V_L = 0\text{V}$, $G = 1$, 90% of V_{OUT} change, $T_A = -40^\circ\text{C}$
V_{OUT} Power Off Time ($V_{DD} \downarrow$)	t_{POFF}	—	0.2	—		$V_{DD} = 3.5\text{V}$ to 0V , $V_{CM} = 0.2\text{V}$, $V_L = 0\text{V}$, $G = 1$, 90% of V_{OUT} change
I_Q Power On Time ($V_{DD} \uparrow$)	t_{PONIQ}	—	21	—		$V_{DD} = 0\text{V}$ to 3.5V , $V_{CM} = 0.2\text{V}$, $V_L = 0\text{V}$, $G = 1$, 90% of I_Q change
		—	58	—		$V_{DD} = 0\text{V}$ to 3.5V , $V_{CM} = 0.2\text{V}$, $V_L = 0\text{V}$, $G = 1$, 90% of I_Q change, $T_A = -40^\circ\text{C}$
I_Q Power Off Time ($V_{DD} \downarrow$)	t_{POFFIQ}	—	0.2	—		$V_{DD} = 3.5\text{V}$ to 0V , $V_{CM} = 0.2\text{V}$, $V_L = 0\text{V}$, $G = 1$, 90% of I_Q change
Trim Power On Time ($V_{DD} \uparrow$)	t_{PON_TR}	—	235	285		Singles, $V_{DD} = 0\text{V}$ to 3.5V , $V_{CM} = 0\text{V}$, $G_N = 1$, all trims to 100% (time when I_{DD} changes from $\geq I_{Q_TR}$ to $\geq I_Q$)
		—	285	335		Duals and Quads, $V_{DD} = 0\text{V}$ to 3.5V , $V_{CM} = 0\text{V}$, $G_N = 1$, all trims to 100% (time when I_{DD} changes from $\geq I_{Q_TR}$ to $\geq I_Q$)

Note 1: t_{ODR} includes some uncertainty due to clock edge timing.

TABLE 1-3: TEMPERATURE SPECIFICATIONS

Electrical Characteristics: Unless otherwise indicated, all limits are specified for: V _{DD} = 2.2V to 5.5V and V _{SS} = GND.						
Parameters	Sym.	Min.	Typ.	Max.	Units	Conditions
Temperature Ranges						
Specified Temperature Range	T _A	-40	—	+125	°C	
Operating Temperature Range		-40	—	+150		(Note 1)
Storage Temperature Range		-65	—	+150		Powered off
Thermal Package Resistances						
Thermal Resistance, 5L-SC70	θ _{JA}	—	209	—	°C/W	
Thermal Resistance, 5L-SOT-23		—	201	—		
Thermal Resistance, 8L-MSOP		—	211	—		
Thermal Resistance, 14L-TSSOP		—	100	—		

Note 1: Operation must not cause T_J to exceed the Absolute Maximum Junction Temperature Rating (+150°C).

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1.3 Timing Diagrams

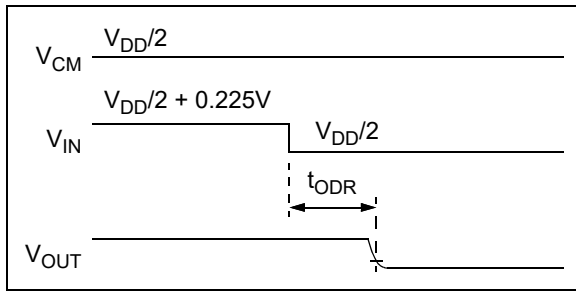


FIGURE 1-1: Output Overdrive Recovery Timing Diagram ($G = -10$ and $V_{DD} = 3.5V$).

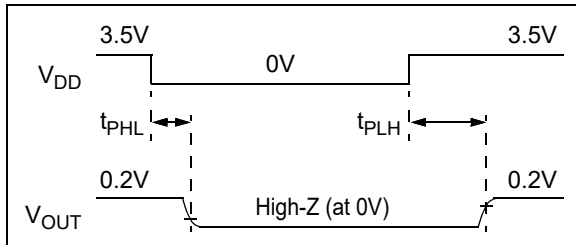


FIGURE 1-2: POR Timing Diagram ($G = 1$, $V_{CM} = 0.2V$ and $V_L = 0V$).

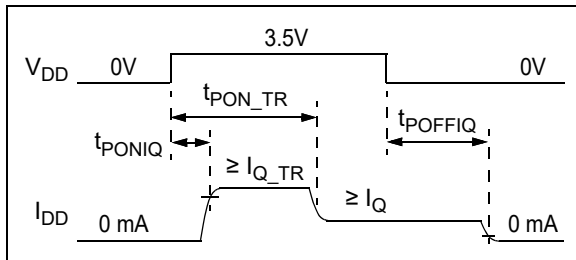


FIGURE 1-3: Supply Current Power Up/Down Timing Diagram ($G = 1$, $V_{CM} = 0.2V$ and $V_L = 0V$).

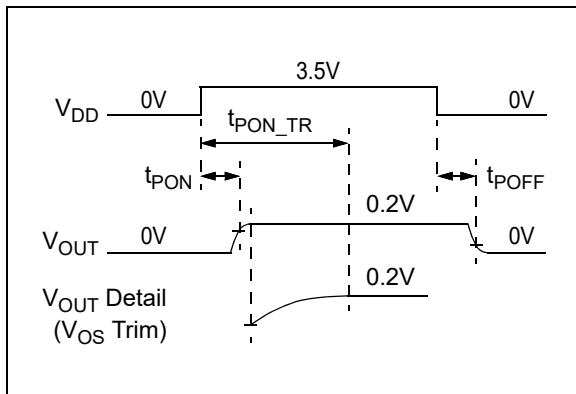


FIGURE 1-4: Output Voltage Power On/Off Timing Diagram, with $V_L = 0V$ ($G = 1$, $V_{CM} = 0.2V$ and $V_L = 0V$).

1.4 Test Circuits

Figure 1-5 shows the circuit used for many DC tests. It sets the Common Mode Input Voltage (V_{CM}) and the Output Voltage (V_{OUT}), as shown in Equation 1-1.

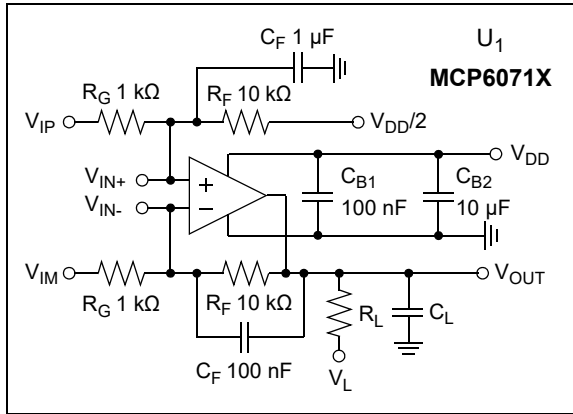


FIGURE 1-5: DC Bench Test Circuit.

EQUATION 1-1:

$$G_{DM} = \frac{R_F}{R_G}$$

$$V_{CM} = \frac{V_{IN+} + V_{IN-}}{2}$$

$$V_{CM} \approx \frac{V_{IP} \cdot G_{DM} + \frac{V_{DD}}{2}}{G_{DM} + 1}$$

$$V_{OST} = V_{IN-} - V_{IN+}$$

$$V_{OUT} = \frac{V_{DD}}{2} + (V_{IP} - V_{IM}) \cdot G_{DM} + V_{OST} \cdot (G_{DM} + 1)$$

Where:

- G_{DM} = Differential-mode Gain (V/V)
- R_F = Feedback Resistance (kΩ)
- R_G = Gain Resistance (kΩ)
- V_{CM} = Common Mode Input Voltage (V)
- V_{IN+} = Noninverting Input Voltage (V)
- V_{IN-} = Inverting Input Voltage (V)
- V_{IP} = Positive Signal Input (V)
- V_{DD} = Supply Voltage (V)
- V_{OST} = Total Input Offset Voltage (mV)
- V_{OUT} = Output Voltage (V)
- V_{IM} = Negative Signal Input (V)

The total Input Offset Voltage (V_{OST}) is described in detail in Section 4.2.3.1, [Input Offset Voltage Errors](#). The circuit's common mode input voltage is V_{CMX} , as shown in Equation 1-2.

EQUATION 1-2:

$$V_{CMX} = \frac{V_{IP} + V_{IM}}{2}$$

Where:

- V_{CMX} = Common Mode Input Voltage (V)
- V_{IP} = Positive Signal Input (V)
- V_{IM} = Negative Signal Input (V)

Figure 1-6 shows the circuit used for many AC tests. Ground V_{IM} to make the gain noninverting or ground V_{IP} to make the gain inverting. Keep the operational amplifier stable and fast by making the R-C poles caused by the input capacitances faster than the designed bandwidth (see Equation 1-3).

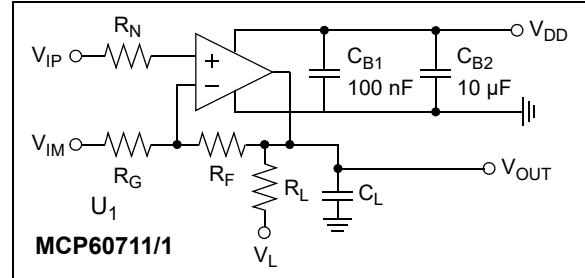


FIGURE 1-6: AC Bench Test Circuit.

EQUATION 1-3:

$$G_N = 1 + \frac{R_F}{R_G}$$

$$f_{BW} \approx \frac{GBWP}{G_N}, \text{ where } G_N > +2$$

For Speed: $R_N < \frac{1}{4\pi f_{BW} \cdot (C_{CM} + C_{DM})}$

For Stability: $R_F \parallel R_G < \frac{1}{4\pi f_{BW} \cdot (C_{CM} + C_{DM})}$

Where:

- G_N = Noise Gain (V/V)
- R_F = Feedback Resistance (kΩ)
- R_G = Gain Resistance (kΩ)
- f_{BW} = Bandwidth Frequency (MHz)
- $GBWP$ = Gain-Bandwidth Product (MHz)
- R_N = Noise Resistance (Ω)
- C_{CM} = Common Mode Input Capacitance (pF)
- C_{DM} = Differential Mode Input Capacitance (pF)

2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

Note: Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

2.1 DC Input Precision

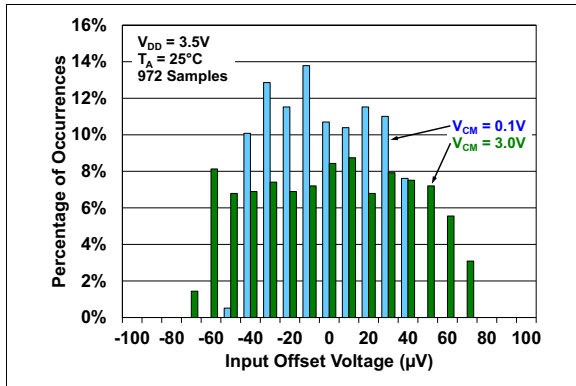


FIGURE 2-1: Input Offset Voltage Before Aging.

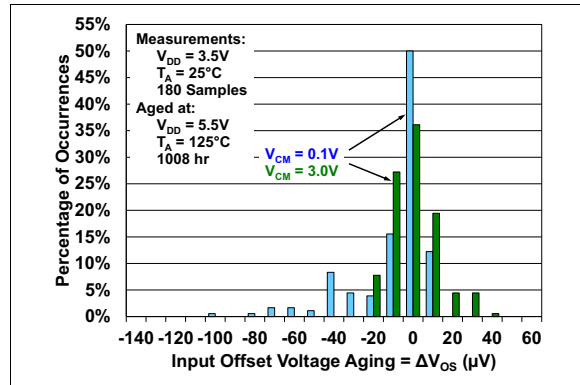


FIGURE 2-4: Aging of the Input Offset Voltage.

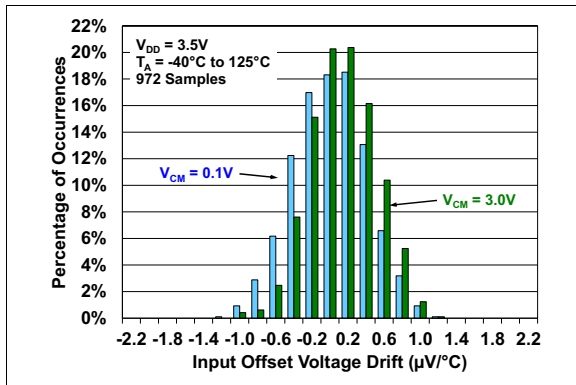


FIGURE 2-2: Input Offset Voltage Drift.

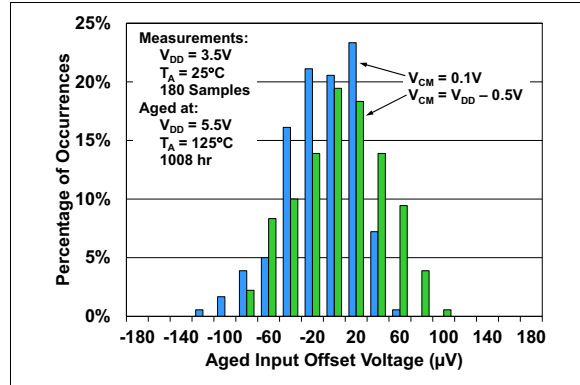


FIGURE 2-5: Input Offset Voltage After Aging.

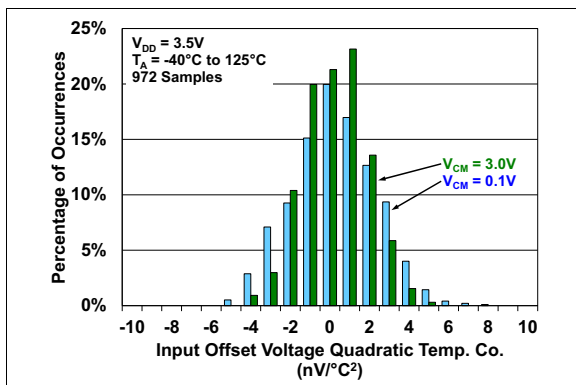


FIGURE 2-3: Input Offset Voltage Quadratic Temp. Co.

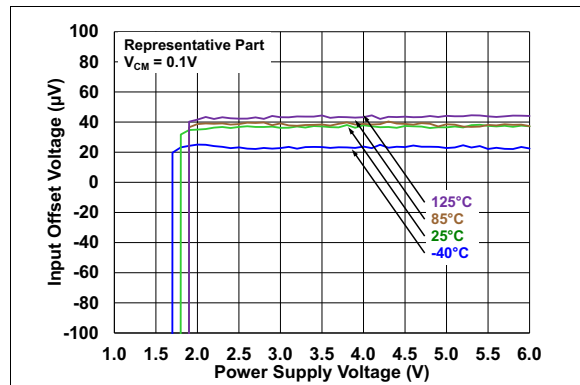


FIGURE 2-6: Input Offset Voltage vs. Power Supply Voltage, with $V_{CM} = 0.1\text{V}$.

Note: Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

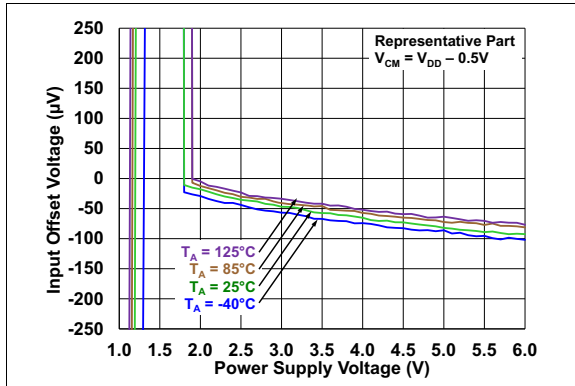


FIGURE 2-7: Input Offset Voltage vs. Power Supply Voltage, with $V_{CM} = V_{DD} - 0.5\text{V}$.

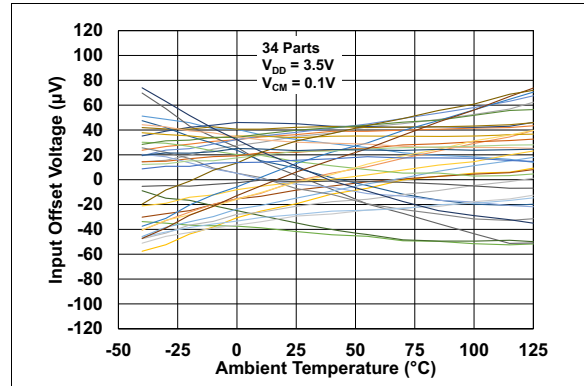


FIGURE 2-10: Input Offset Voltage vs. Temperature, with $V_{DD} = 3.5\text{V}$ and $V_{CM} = 0.1\text{V}$.

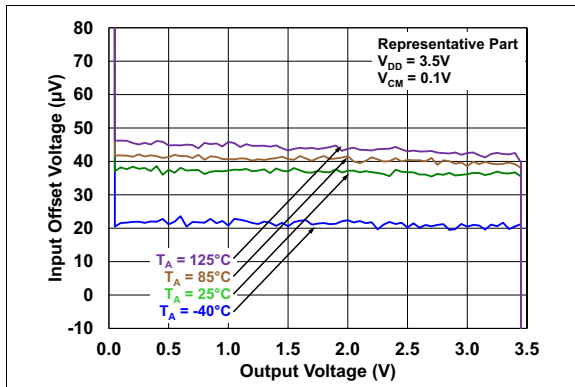


FIGURE 2-8: Input Offset Voltage vs. Output Voltage, with $V_{DD} = 3.5\text{V}$.

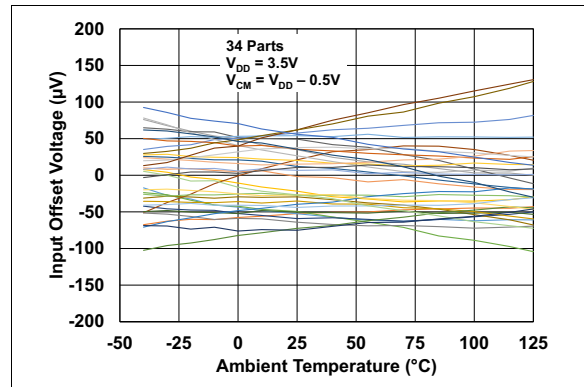


FIGURE 2-11: Input Offset Voltage vs. Temperature, with $V_{DD} = 3.5\text{V}$ and $V_{CM} = V_{DD} - 0.5\text{V}$.

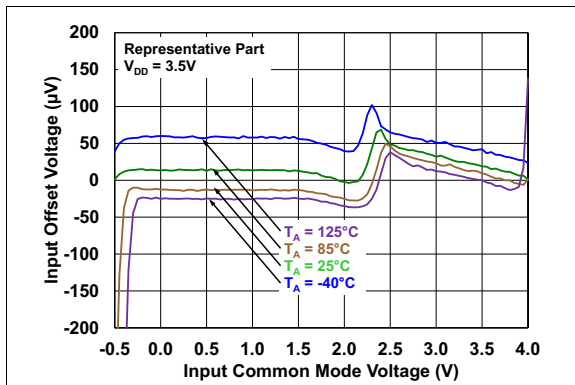


FIGURE 2-9: Input Offset Voltage vs. Input Common Mode Voltage, with $V_{DD} = 3.5\text{V}$.

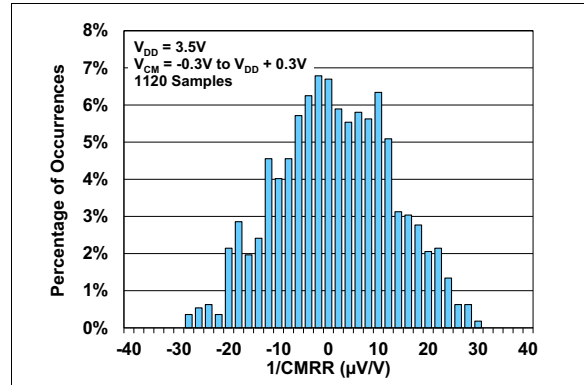


FIGURE 2-12: Common Mode Rejection Ratio, with $V_{DD} = 3.5\text{V}$.

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Note: Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

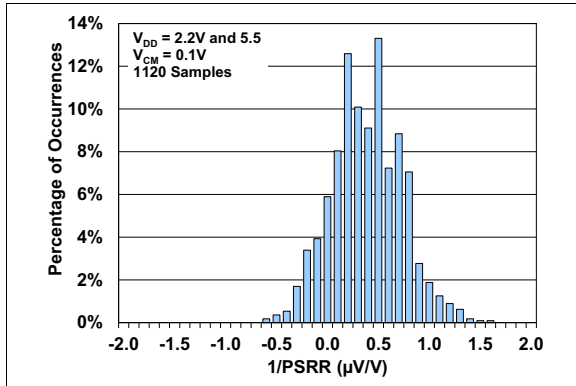


FIGURE 2-13: Power Supply Rejection Ratio, with $V_{CM} = 0.1\text{V}$.

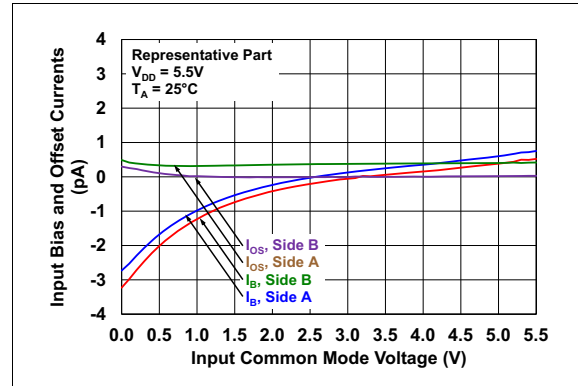


FIGURE 2-16: Input Bias and Offset Currents vs. Common Mode Input Voltage, with $T_A = +25^\circ\text{C}$.

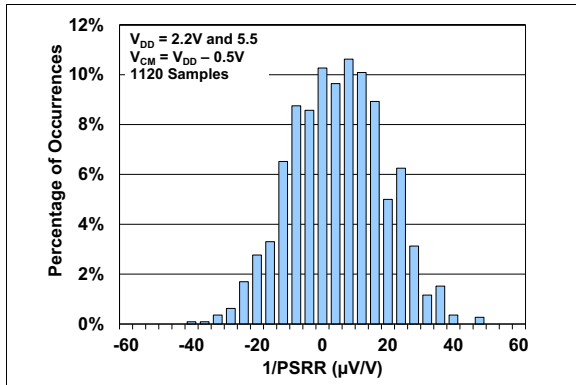


FIGURE 2-14: Power Supply Rejection Ratio, with $V_{DD} - 0.5\text{V}$.

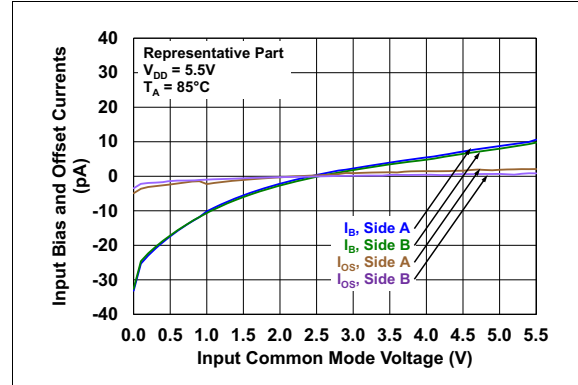


FIGURE 2-17: Input Bias and Offset Currents vs. Common Mode Input Voltage, with $T_A = +85^\circ\text{C}$.

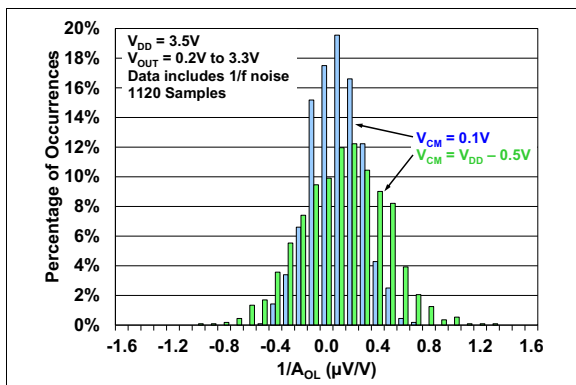


FIGURE 2-15: DC Open-Loop Gain, with $V_{CM} = 0.1\text{V}$ and $V_{DD} - 0.5\text{V}$.

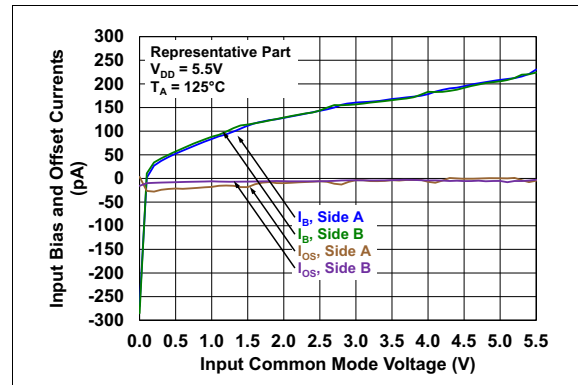


FIGURE 2-18: Input Bias and Offset Currents vs. Common Mode Input Voltage, with $T_A = +125^\circ\text{C}$.

Input Bias and Offset Currents vs. Common Mode Input Voltage, with $T_A = +125^\circ\text{C}$. **Note:** Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

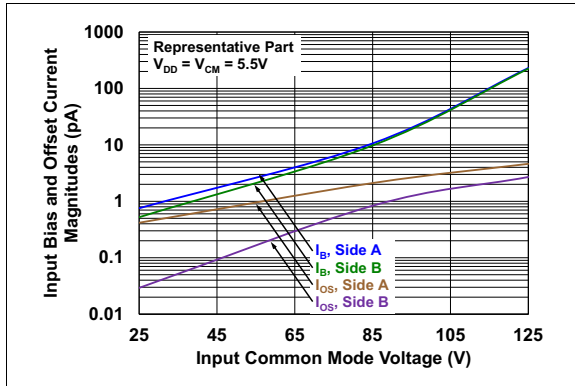


FIGURE 2-19: Input Bias and Offset Currents vs. Ambient Temperature, with $V_{DD} = 5.5$.

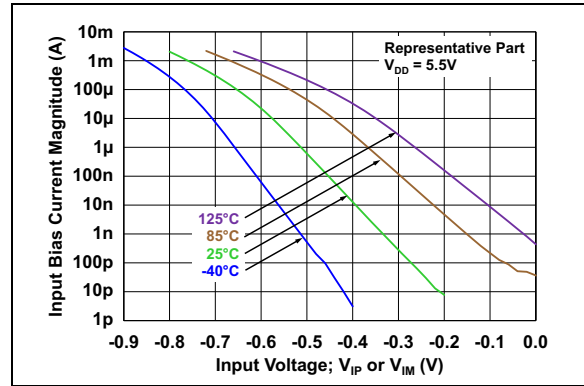


FIGURE 2-20: Input Bias Currents vs. Input Voltage (below V_{SS}).

2.2 Other DC Voltages and Currents

Note: Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

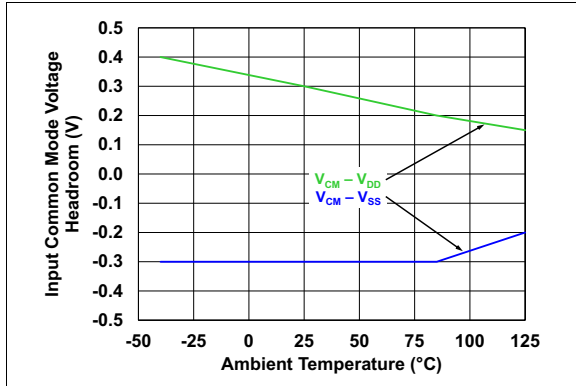


FIGURE 2-21: Input Common Mode Voltage Headroom (Range) vs. Ambient Temperature.

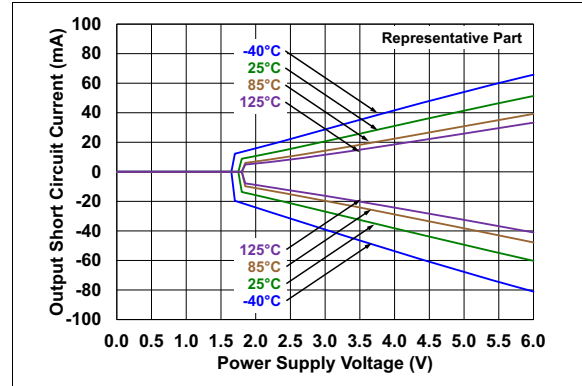


FIGURE 2-24: Output Short Circuit Current vs. Power Supply Voltage.

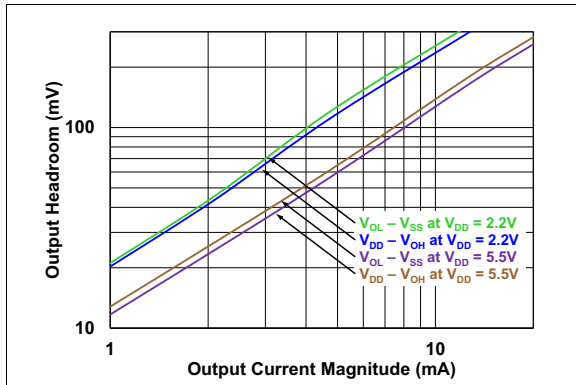


FIGURE 2-22: Output Voltage Headroom vs. Output Current.

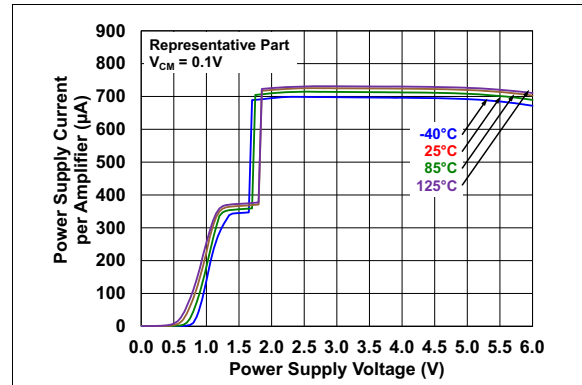


FIGURE 2-25: Supply Current vs. Power Supply Voltage.

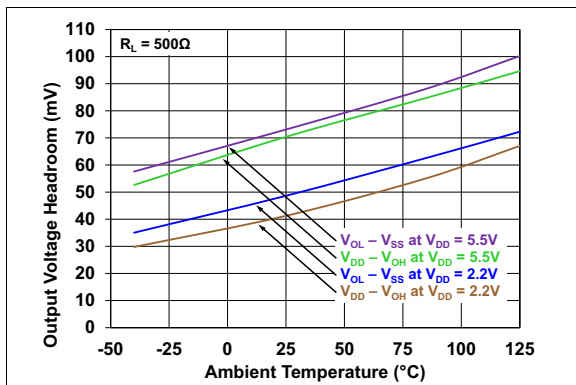


FIGURE 2-23: Output Voltage Headroom vs. Ambient Temperature.

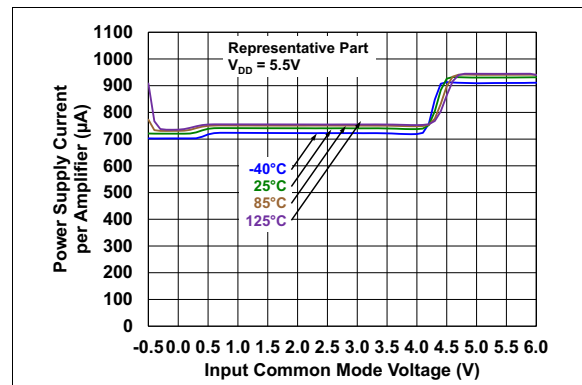


FIGURE 2-26: Supply Current vs. Common Mode Input Voltage, with $V_{DD} = 5.5\text{V}$.

2.3 Frequency Response

Note: Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

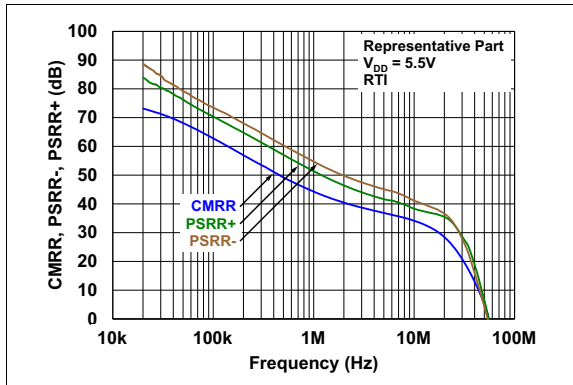


FIGURE 2-27: CMRR and PSRR vs. Frequency.

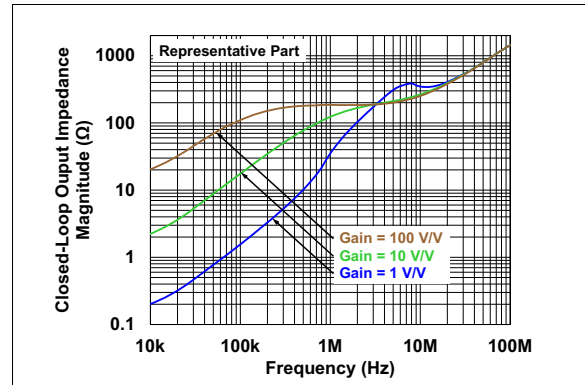


FIGURE 2-30: Closed-Loop Output Impedance vs. Frequency.

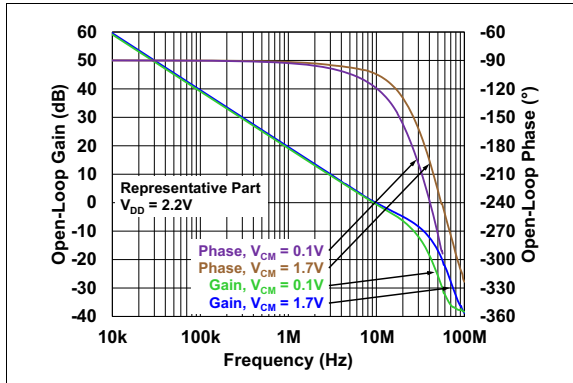


FIGURE 2-28: Open-Loop Gain vs. Frequency, with $V_{DD} = 2.2\text{V}$.

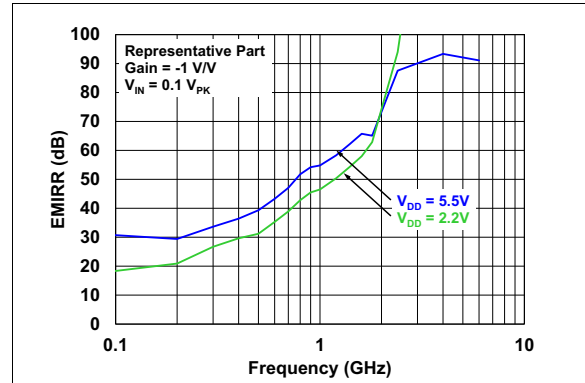


FIGURE 2-31: EMIRR vs. Frequency.

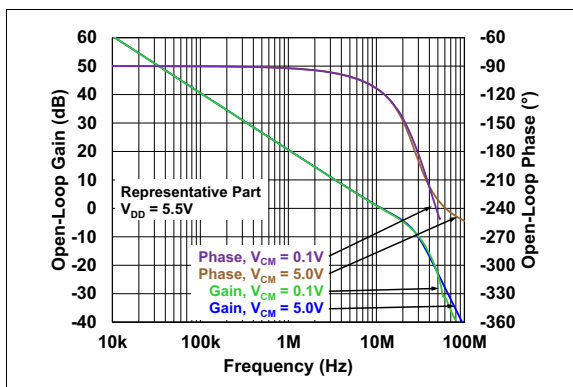


FIGURE 2-29: Open-Loop Gain vs. Frequency, with $V_{DD} = 5.5\text{V}$.

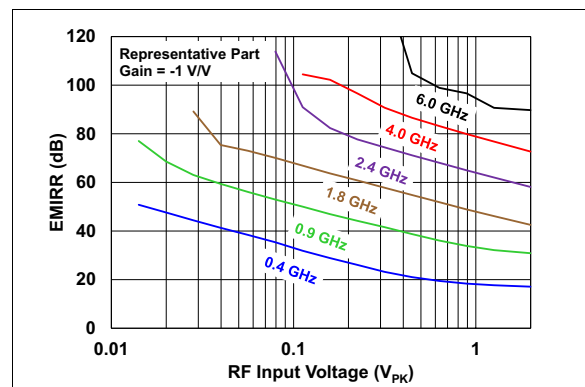


FIGURE 2-32: EMIRR vs. RF Input Voltage.

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Note: Unless otherwise indicated, $T_A = 25^{\circ}\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

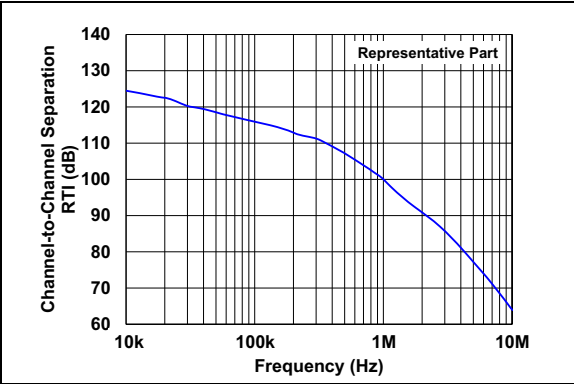


FIGURE 2-33: Channel-to-Channel Separation vs. Frequency.

2.4 Input Noise and Distortion

Note: Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

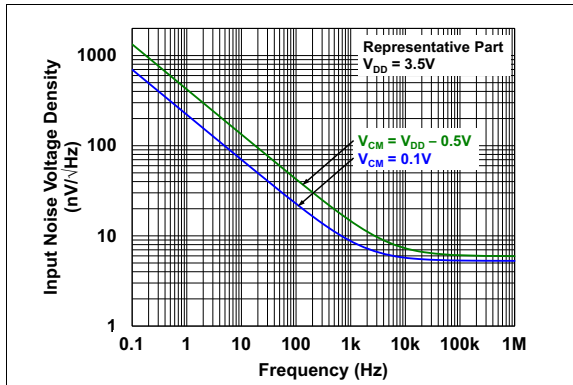


FIGURE 2-34: Input Noise Voltage Density vs. Frequency.

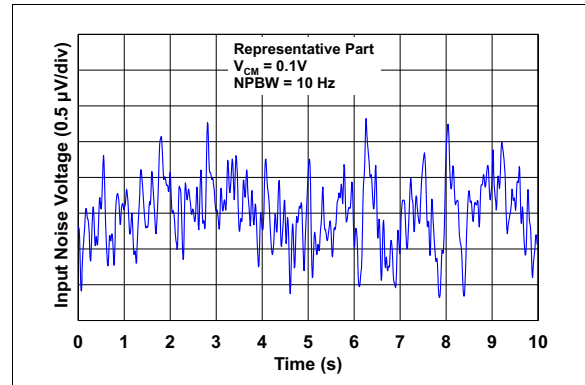


FIGURE 2-36: Input Noise vs. Time, with a 0.1 Hz to 10 Hz Band-pass Filter and $V_{CM} = 0.1\text{V}$.

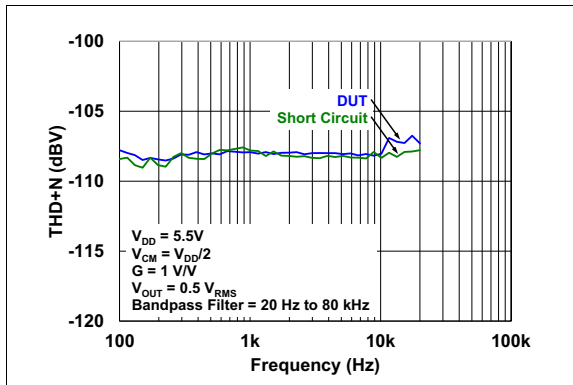


FIGURE 2-35: Total Harmonic Distortion plus Noise vs. Frequency.

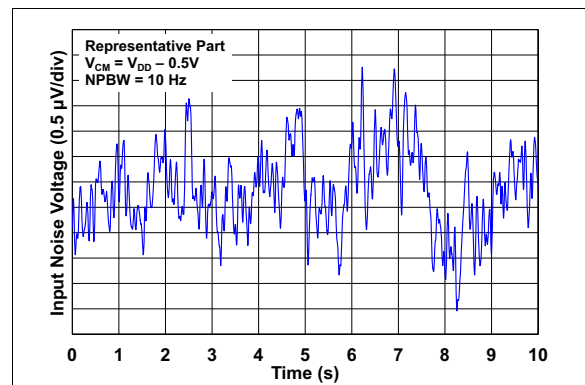


FIGURE 2-37: Input Noise vs. Time, with a 0.1 Hz to 10 Hz Band-pass Filter and $V_{CM} = V_{DD} - 0.5\text{V}$.

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2.5 Time Response

Note: Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

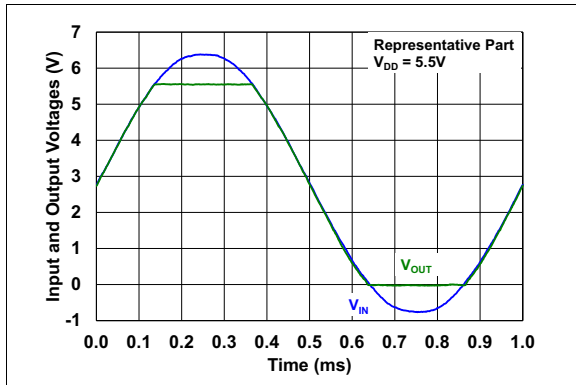


FIGURE 2-38: The MCP60711/1U/2/4 Family Shows no Input Phase Reversal with Overdrive.

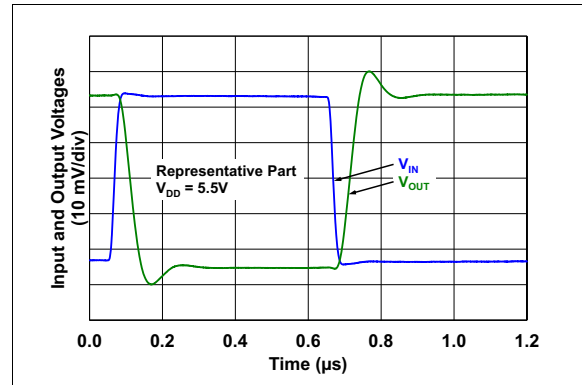


FIGURE 2-41: Inverting Small Signal Step Response.

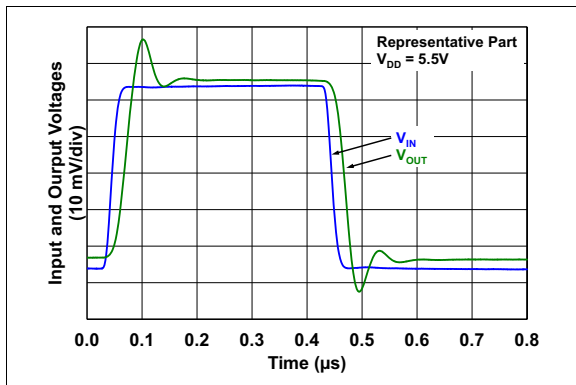


FIGURE 2-39: Noninverting Small Signal Step Response.

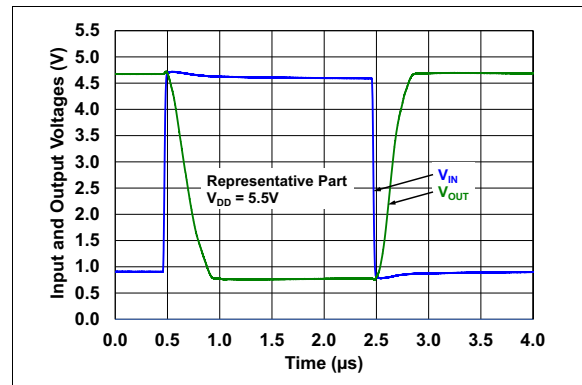


FIGURE 2-42: Inverting Large Signal Step Response.

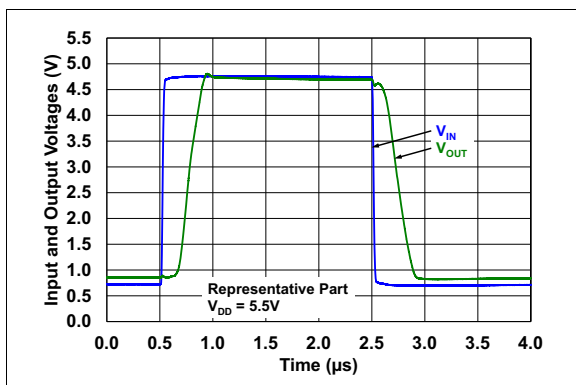


FIGURE 2-40: Noninverting Large Signal Step Response.

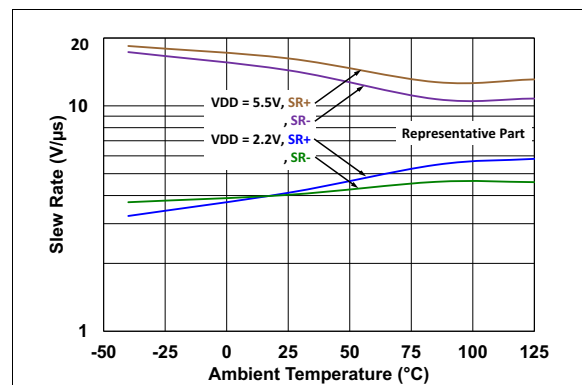


FIGURE 2-43: Slew Rate vs. Ambient Temperature.

Note: Unless otherwise indicated, $T_A = 25^\circ\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

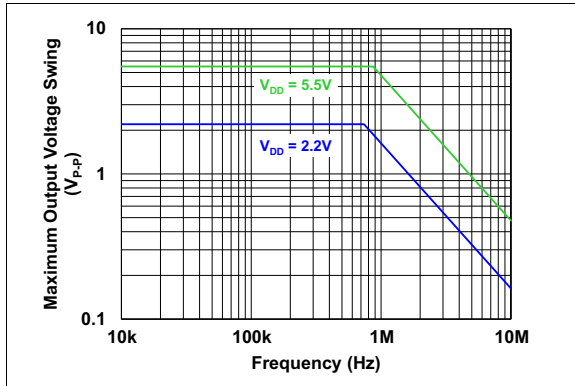


FIGURE 2-44: Maximum Output Voltage Swing vs. Frequency.

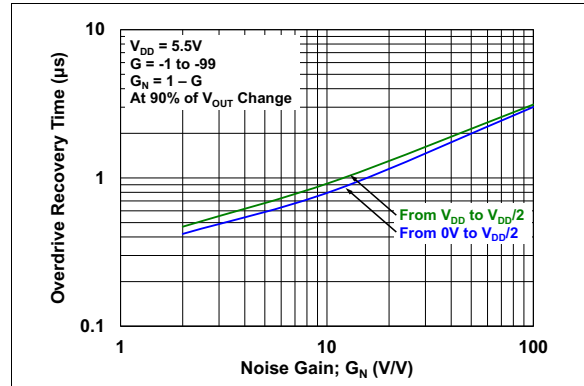


FIGURE 2-45: Output Overdrive Recovery Time vs. Noise Gain.

2.6 Capacitive Loads

Note: Unless otherwise indicated, $T_A = 25^{\circ}\text{C}$, $V_{DD} = 3.5\text{V}$, $V_{SS} = \text{GND}$, $V_{CM} = 0.1\text{V}$, $V_{OUT} = V_{DD}/2$, $V_L = V_{DD}/2$, $R_L = 5\text{ k}\Omega$ to V_L and $C_L = 30\text{ pF}$.

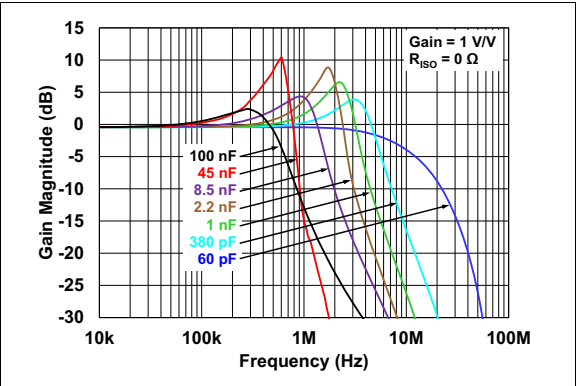


FIGURE 2-46: Gain Magnitude vs. Frequency, with Uncompensated Capacitive Loads and Gain = 1 V/V.

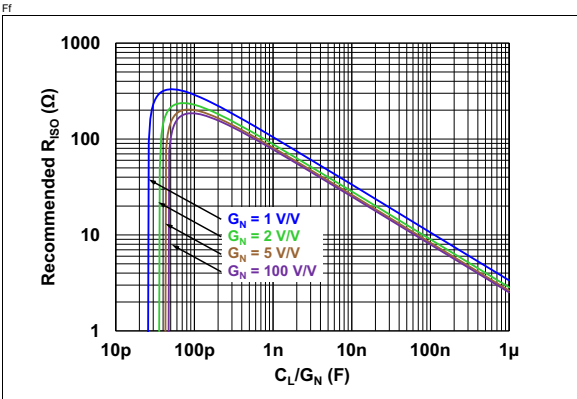


FIGURE 2-48: Recommended R_{ISO} vs. Normalized Capacitive Load (see [Section 4.2.4](#)).

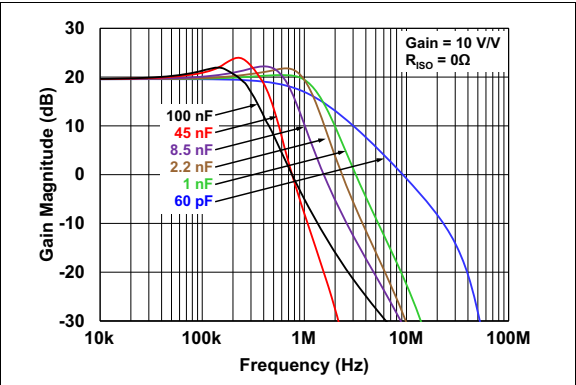


FIGURE 2-47: Gain Magnitude vs. Frequency, with Uncompensated Capacitive Loads and Gain = 10 V/V.

3.0 PIN DESCRIPTIONS

Descriptions of the pins are listed in [Table 3-1](#).

TABLE 3-1: PIN FUNCTION TABLE

MCP60711	MCP60711U	MCP60712	MCP60714	Symbols	Op Amp	Description
SOT-23	SC70	MSOP	TSSOP			
1	4	1	1	V_{OUT}, V_{OUTA}	A	Output
4	3	2	2	V_{IN}^{-}, V_{INA}^{-}		Inverting Input
3	1	3	3	V_{IN}^{+}, V_{INA}^{+}		Noninverting Input
5	5	8	4	V_{DD}	All	Positive Power Supply
—	—	5	5	V_{INB}^{+}	B	Noninverting Input
		6	6	V_{INB}^{-}		Inverting Input
		7	7	V_{OUTB}		Output
		—	8	V_{OUTC}	C	Inverting Input
			9	V_{INC}^{-}		
			10	V_{INC}^{+}		
2	2	4	11	V_{SS}	All	Negative Power Supply
—	—	—	12	V_{IND}^{+}	D	Noninverting Input
			13	V_{IND}^{-}		Inverting Input
			14	V_{OUTD}		Output

3.1 Analog Outputs

The output pin is a low-impedance voltage source.

3.2 Analog Inputs

The noninverting and inverting inputs are high-impedance CMOS inputs with low bias currents.

3.3 Power Supply Pins

For normal operation, the positive power supply (V_{DD}) is 2.2V to 5.5V higher than the negative power supply (V_{SS}). Also, the output (V_{OUT}) is between V_{SS} and V_{DD} , while the V_{CM} range is larger (see the V_{CML} and V_{CMH} specs and [Figure 2-21](#)).

Typically, these parts are used in a single (positive) supply configuration. In this case, V_{SS} is connected to ground and V_{DD} is connected to the supply. V_{DD} needs a bypass capacitor.

Dual (or split) supply configurations connect the V_{DD} and V_{SS} pins to their respective supply voltages; the supply also has a circuit ground connection. Both V_{DD} and V_{SS} need bypass capacitors.

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4.0 APPLICATION INFORMATION

The MCP6071X device family of op amps is manufactured using a state-of-the-art CMOS process and is specifically designed for low-cost, high speed and DC precision.

4.1 Op Amp Operation

4.1.1 ABSOLUTE MAXIMUM RATINGS

The Absolute Maximum Ratings (see [Section 1.1, Absolute Maximum Ratings †](#)) are independent of each other; all of them must be enforced by the user. Being at, or near, two or more Absolute Maximum Ratings at the same time may decrease MCP6071X reliability.

4.1.2 RAIL-TO-RAIL INPUTS

4.1.2.1 Phase Reversal

The MCP60711/1U/2/4 op amps are designed to prevent phase reversal when the input pins exceed the supply voltages. [Figure 2-38](#) shows the input voltage exceeding the supply voltage without any phase reversal.

4.1.2.2 Input Voltage and Current Limits

The ESD protection on the inputs can be depicted as shown in [Figure 4-1](#). This structure was chosen to protect the input transistors, and to minimize input bias current (I_B). The input ESD diodes clamp the inputs when they try to go more than one diode drop below V_{SS} or more than one diode drop above V_{DD} .

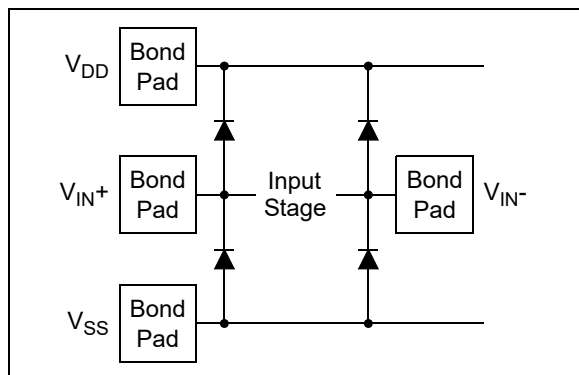


FIGURE 4-1: Simplified Analog Input ESD Structures.

In order to prevent damage and/or improper operation of these amplifiers, the circuit must limit the currents (and voltages) at the input pins (see [Section 1.1, Absolute Maximum Ratings †](#)). [Figure 4-2](#) shows the recommended approach to protecting these inputs. The resistors R_1 and R_2 limit the possible currents at the input pins.

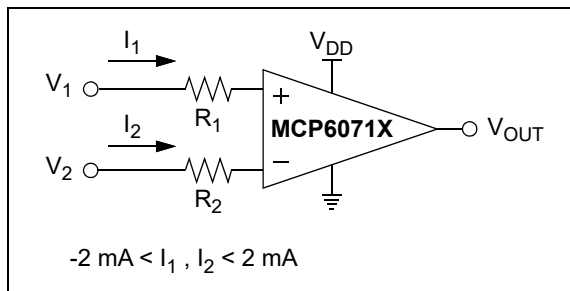


FIGURE 4-2: Protecting the Analog Inputs.

A significant amount of current can flow out of the inputs (through the ESD diodes) when the common mode voltage (V_{CM}) is below ground (V_{SS}); see [Figure 2-19](#).

The differential input voltage ($V_{DM} = V_{IN+} - V_{IN-}$) needs to be limited for normal operations; keep its magnitude below ± 50 mV. Ways to accomplish this include: keep bias voltages within their specified and absolute maximum ranges at all times, keep power up and down times short and keep V_{OUT} 's slope magnitude below the slew rate (SR).

4.1.3 INPUT ERRORS

The input offset voltage (V_{OS}) is trimmed at $V_{CM} = 0.1V$ and $V_{CM} = V_{DD} - 0.5V$, which gives good V_{OS} and CMRR.

Reducing stresses (mechanical, thermal and electrical) improves input offset aging. This benefits applications with long lifetimes and calibration requirements.

The input bias current (I_B) and input offset current (I_{OS}) are low across temperature; they support many applications.

4.1.4 RAIL-TO-RAIL OUTPUTS

4.1.4.1 Output Voltage Limits

[Figure 2-22](#) and [Figure 2-23](#) show typical values of output headroom versus output current and temperature. Also, [Figure 2-45](#) shows the output overdrive vs. temperature behavior of these parts

4.1.4.2 Output Current Limits

Large output currents, in some cases, may increase the internal junction temperature (T_J) of the output stage too high. For reliable operations, limit the circuit's output current. For details, see [Section 1.1, Absolute Maximum Ratings †](#).

[Figure 4-3](#) show the quantities used in the following power calculations for a single operational amplifier. R_{SER} is 0Ω in most applications. Higher values can be used to limit I_{OUT} . V_{OUT} is the operational amplifier's output voltage, V_L is the voltage at the load and V_{LG} is the load's ground point. V_{SS} is usually ground (0V). The input currents are assumed to be negligible.

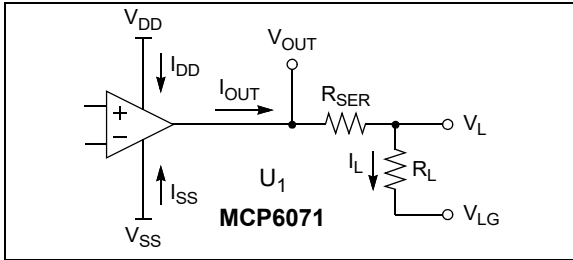


FIGURE 4-3: Diagram for Power Calculation.

The currents shown in Figure 4-3 are calculated using Equation 4-1.

EQUATION 4-1:

$$I_{OUT} = I_L = \frac{V_{OUT} - V_{LG}}{R_{SER} + R_L}$$

$$I_{DD} \approx I_Q + \max(0, I_{OUT})$$

$$I_{SS} \approx -I_Q + \min(0, I_{OUT})$$

Where:

- I_{OUT} = Output Current (mA)
- I_L = Load Current (mA)
- V_{OUT} = Output Voltage (V)
- V_{LG} = Load Ground Point Voltage (V)
- R_{SER} = Series Resistance (kΩ)
- R_L = Load Resistance (kΩ)
- I_{DD} = Positive Supply Current (mA)
- I_Q = Quiescent Supply Current (mA)
- I_{SS} = Negative Supply Current (mA)

The instantaneous operational amplifier power ($P_{OA}(t)$), R_{SER} power ($P_{RSER}(t)$) and load power ($P_L(t)$) are determined as shown in Equation 4-2.

EQUATION 4-2:

$$P_{OA}(t) = I_{DD}(V_{DD} - V_{OUT}) + I_{SS}(V_{SS} - V_{OUT})$$

$$P_{RSER}(t) = I_{OUT}^2 \times R_{SER}$$

$$P_L(t) = I_L^2 \times R_L$$

Where:

- $P_{OA}(t)$ = Instantaneous Operational Amplifier Power (W)
- I_{DD} = Positive Supply Current (mA)
- V_{DD} = Positive Supply Voltage (V)
- V_{OUT} = Output Voltage (V)
- I_{SS} = Negative Supply Current (mA)
- V_{SS} = Negative Supply Voltage (V)
- $P_{RSER}(t)$ = R_{SER} Power (W)
- R_{SER} = Series Resistance (kΩ)
- $P_L(t)$ = Load Power (W)
- I_L = Load Current (mA)
- R_L = Load Resistance (kΩ)

The maximum operational amplifier power dissipation, with resistive loads, occurs when V_{OUT} is halfway between V_{DD} and V_{LG} or halfway between V_{SS} and V_{LG} , as shown in Equation 4-3.

EQUATION 4-3:

$$P_{OAmix} \leq \frac{\max^2(V_{DD} - V_{LG}, V_{LG} - V_{SS})}{4(R_{SER} + R_L)}$$

Where:

- P_{OAmix} = Maximum Power Dissipation (W)
- V_{DD} = Positive Supply Voltage (V)
- V_{LG} = Load Ground Point Voltage (V)
- V_{SS} = Negative Supply Voltage (V)
- R_{SER} = Series Resistance (kΩ)
- R_L = Load Resistance (kΩ)

The maximum ambient to junction temperature rise (ΔT_{JA}) and junction temperature (T_J) is calculated by summing the power dissipation for all operational amplifiers in the same package (ΣP_{OAmix}), the ambient temperature (T_A) and the package thermal resistance (θ_{JA}) found in Table 1-3. The calculation is shown in Equation 4-4.

EQUATION 4-4:

$$\Delta T_{JA} = \theta_{JA} \times \Sigma P_{OAmix}$$

$$T_J = T_A + \Delta T_{JA}$$

Where:

- ΔT_{JA} = Maximum Ambient To Junction Temperature Rise (°C)
- θ_{JA} = Package Thermal Resistance (°C/W)
- P_{OAmix} = Maximum Operational Amplifier Power Dissipation (W)
- T_J = Junction Temperature (°C)
- T_A = Ambient Temperature (°C)

4.1.5 TRIMMED I_Q

I_Q is trimmed and is reasonably flat across temperature (T_A) and supply voltage ($V_{DD} - V_{SS}$), as shown in Figure 2-25. This reduces P_{OAmix} in an application. I_Q increases at higher V_{CM} levels; see Figure 2-26.

4.1.6 EMI REJECTION RATIO (EMIRR)

Electromagnetic interference (EMI) is the disturbance that affects an electrical circuit, due to either electromagnetic induction or radiation, emitted from an external source.

EMIRR helps describe the EMI robustness of an op amp to an interfering RF signal. A common error caused by EMI in circuits is a shift in input offset voltage

(V_{OS}) due to nonlinearities at the input. Another common error source is interference at high frequencies. EMIRR compares the change in V_{OS} to the RF signal's peak voltage, as shown in [Equation 4-5](#).

EQUATION 4-5:

$$EMIRR(dB) = 20 \cdot \log \frac{V_{RF}}{\Delta V_{OS}}$$

Where:

$EMIRR$ = Electromagnetic Interference Rejection Ratio (dB)

V_{RF} = Interfering RF Signal's peak voltage (V_{PK}) (V)

ΔV_{OS} = Input Offset Voltage Shift

Internal passive filters improve EMIRR, but good PCB layout techniques are also necessary for best overall performance.

4.2 Circuit Design

4.2.1 SUPPLY BYPASS

For a positive single supply ($V_{SS} = 0V$ and $V_{DD} > V_{SS}$), the V_{DD} pin needs a local bypass capacitor (usually 10 nF to 100 nF) within 2 mm of the V_{DD} pin; this gives good high-frequency performance. It also needs a bulk capacitor (usually 1 μF or larger) within 10 mm; this provides for large, slow currents. In some cases, but not all, this bulk capacitor can be shared with nearby analog parts.

For split or dual supplies ($V_{SS} < 0V < V_{DD}$), both the V_{DD} pin and the V_{SS} pin need bypass capacitors as previously described.

4.2.2 PCB SURFACE LEAKAGE

In applications where maintaining low input currents is critical, Printed Circuit Board (PCB) leakage currents must be minimized. These PCB leakage currents are mainly caused by humidity, dust or other contaminants on the PCB surfaces.

The following techniques can help to reduce PCB leakage currents:

- Place critical input traces in inner layers
- Use conformal coating
- Use guard rings where possible (packages with tightly spaced pins can limit this approach)

4.2.3 LOW OFFSETS

4.2.3.1 Input Offset Voltage Errors

The data sheet parameters that describe DC voltage errors at the op amp's input act to internally increase the voltage at the noninverting input (see [Figure 4-4](#)). These parameters are: V_{OS} , TC_1 , TC_2 , $CMRR$, $PSRR$ and A_{OL} (see the [DC Electrical Specifications](#) table).

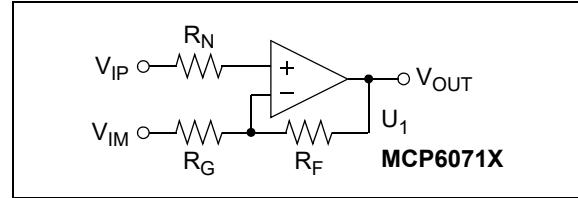


FIGURE 4-4: Op Amp Feedback Network.

The combined errors are:

EQUATION 4-6:

$$V_{OST} = V_{OS} + TC_1(T_A - 25^\circ C) + TC_2(T_A - 25^\circ C)^2 + \Delta V_{CM}/CMRR + \Delta V_{OUT}/A_{OL} + \Delta(V_{DD} - V_{SS})/PSRR$$

Where:

V_{OST} = total input offset voltage (error)
1/CMRR, 1/ A_{OL} and 1/PSRR have units of $\mu V/V$ (e.g., $\pm 100 \mu V/V$ corresponds to 80 dB)

The error referred to V_{OUT} is:

EQUATION 4-7:

$$V_{OERR} = G_N V_{OST}$$

Where:

V_{OERR} = total output offset voltage (error)
 G_N = the circuit's DC "Noise Gain"
 $= 1 + R_F/R_G$, in [Figure 4-4](#)

[Section 4.1.2.2, Input Voltage and Current Limits](#) gives ways to minimize the input differential voltage (V_{DM}), which can help to reduce ΔV_{OS} aging. When possible, also operate at lower V_{DD} and T_A . Other conditions that may affect ΔV_{OS} include:

- Exposure to maximum rating conditions for extended periods of time
- Mechanical stress, which can be reduced at the PCB/enclosure level.

4.2.3.2 Input Bias Current Errors

The Input Bias Current (I_B) and Input Offset Current (I_{OS}) cause voltage drops across resistors in the circuit, increasing the voltage errors. These currents are positive when they go into the op amp, so the circuit in [Figure 4-4](#) gives:

EQUATION 4-8:

$$V_{TIBE} = (I_B - I_{OS}/2) (R_F || R_G) - (I_B + I_{OS}/2) R_N$$

$$V_{TOBE} = G_N V_{TIBE}$$

Where:

V_{TIBE} = total input bias current error

V_{TOBE} = total output bias current error

G_N is defined in Equation 4-7

Note that the PCB leakage currents discussed in Section 4.2.2, [PCB Surface Leakage](#) add additional DC errors to the circuit. These errors depend on where these currents are injected into the circuit. Standard circuit analysis techniques will give the output error.

4.2.4 CAPACITIVE LOADS

Driving large capacitive loads can cause stability problems for op amps. As the load capacitance increases, the feedback loop's phase margin decreases and the closed-loop bandwidth is reduced. This produces gain peaking in the signal's frequency response (see Figure 2-46 and Figure 2-47) and overshoot and ringing in the step response. A unity-gain buffer ($G = +1$) is the most sensitive to capacitive loads, though all gains show the same general behavior. See Section 2.6, [Capacitive Loads](#) for plots of typical behavior.

When driving large capacitive loads (e.g., $C_L > 30$ pF when $G = +1$), a small series resistor at the output (R_{ISO} in Figure 4-5) improves the feedback loop's phase margin (stability) by making the output load resistive at higher frequencies. The bandwidth will be generally lower than the bandwidth with no capacitive load.

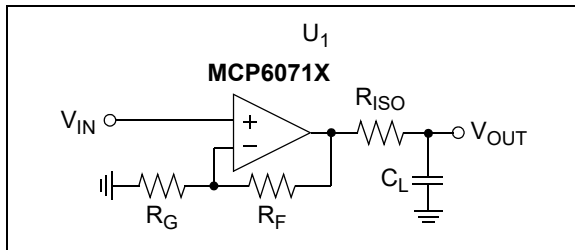


FIGURE 4-5: *Compensating a Capacitive Load (C_L) with R_{ISO} .*

Figure 2-48 gives recommended R_{ISO} values for different capacitive loads and gains. The x-axis is the normalized load capacitance (C_L/G_N), where G_N is the circuit's noise gain. For noninverting gains, G_N and the Signal Gain are equal. For inverting gains, G_N is $1 + |\text{Signal Gain}|$ (e.g., -1 V/V gives $G_N = +2$ V/V).

After selecting R_{ISO} for your circuit, double-check the resulting frequency response peaking and step response overshoot. Modify R_{ISO} 's value until the response is reasonable. Bench evaluation of R_{ISO} 's effect on a specific design is important.

4.2.5 ESTIMATING THE BANDWIDTH

The three most common op amp circuits are represented by Figure 4-6: noninverting gain ($R_{PF} = \text{open}$ and V_{IM} grounded), inverting gain ($R_{PF} = \text{open}$ and V_{IP} grounded) and differential (difference) gain.

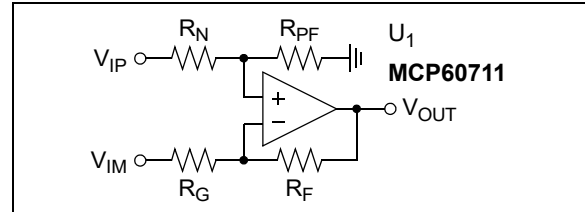


FIGURE 4-6: *Common Op Amp Configurations.*

The Noise Gain and Small Signal Bandwidth are:

EQUATION 4-9:

$$G_N = 1 + R_F/R_G$$

$$BW \approx GBWP/G_N, \quad G_N > 2$$

The Full Power Bandwidth (FPBW) is the frequency where a large output sine wave's maximum slope equals the Slew Rate (SR):

EQUATION 4-10:

$$V_{OPP} = \text{Peak-to-Peak Output Voltage, } (V_{P-P})$$

$$FPBW \approx |SR|/(\pi V_{OPP}), \quad (\text{Hz})$$

For accurate AC gains, set BW higher than the input signal's bandwidth (e.g., a 10 to 1 ratio). For low harmonic distortion, set FPBW higher than BW (e.g., a 3 to 1 ratio).

4.2.6 GAIN PEAKING

Figure 4-7 shows an op amp circuit that represents noninverting amplifiers (V_M is a DC voltage and V_P is the input) or inverting amplifiers (V_P is a DC voltage and V_M is the input). The capacitances C_N and C_G represent the total capacitance at the input pins; they include the op amp's Common Mode Input Capacitance (C_{CM}), board parasitic capacitance and any capacitor placed in parallel.

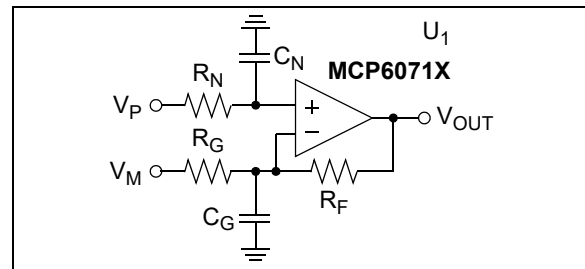


FIGURE 4-7: *Amplifier with Parasitic Capacitance.*

MCP60711/1U/2/4

C_G acts in parallel with R_G (except for a gain of +1 V/V), which causes an increase in gain at high frequencies. C_G also reduces the phase margin of the feedback loop, which becomes less stable. This effect can be reduced by either reducing C_G and/or $R_F||R_G$ so that:

EQUATION 4-11:

$$2 \text{ BW} \leq 1 / (2\pi(R_F||R_G)C_G)$$

C_N and R_N form a low-pass filter that affects the signal at V_{IP} . This filter has a single real pole at $1/(2\pi R_N C_N)$. Usually, this pole should be faster than the BW:

EQUATION 4-12:

$$2 \text{ BW} \leq 1 / (2\pi R_N C_N)$$

It is also possible to add a capacitor (C_F) in parallel with R_F to compensate for the destabilizing effect of C_G , making it possible to use larger values of R_F . This will also reduce the bandwidth at higher gain. The conditions for stability are shown in [Figure 4-13](#).

It pays to simulate the circuit after making these changes. Be sure to include all of the significant capacitances and inductances, including parasitic ones.

EQUATION 4-13:

Given:

$$G_{N1} = 1 + R_F/R_G$$

$$G_{N2} = 1 + C_G/C_F$$

$$f_F = 1 / (2\pi R_F C_F), \text{ response pole}$$

$$f_Z = f_F (G_{N1}/G_{N2}), \text{ response zero}$$

We need:

$$f_F \leq \text{GBWP}/(2G_{N2}), \quad G_{N1} < G_{N2}$$

$$f_F \leq \text{GBWP}/(4G_{N1}), \quad G_{N1} > G_{N2}$$

4.2.7 POWER UP/DOWN

The “Power Up/Down” section of [Table 1-2](#) specifies how I_Q and V_{OUT} behave when power pin (V_{DD}) turns the part on and off, using the internal POR circuit.

When powered up, the part quickly becomes operational (t_{PONIQ} and t_{PON}). It will use extra current (I_{Q_TR}) for a short time (t_{PON_TR}) to complete the internal trims. During this time, V_{OS} and I_Q settle to their final values.

When powered down, the part quickly turns off (t_{POFFIQ} and t_{POFF}). Once off, $I_Q = 0 \mu\text{A}$ (since $V_{DD} = V_{SS}$).

When powering up and down smoothly, make sure that V_{DD} ramps up and down smoothly and quickly between 0V and 2.2V. This helps the internal digital circuitry to operate as specified.

4.2.8 NOISE

[Figure 2-34](#) shows the Input Noise Voltage Density across frequency ($e_{ni}(f)$). The corresponding Integrated Output Noise Voltage (E_{no}) is the RMS noise seen at the output due to $e_{ni}(f)$ and the Noise Gain across frequency ($G_N(f)$), which is the gain from the op amp's noninverting input to its output). E_{no} is calculated as follows:

EQUATION 4-14:

$$E_{ni}^2(f_L, f_H) = \int_{f_L}^{f_H} e_{ni}^2(f) G_N^2(f) df$$

E_{ni} has units of $\text{nV}/\sqrt{\text{Hz}}$. E_{ni} has two common units: μV_{RMS} (RMS value) and $\mu\text{V}_{\text{P.P}}$ (Peak-to-Peak value). The E_{ni} specification (in [Table 1-2](#)) has units of $\mu\text{V}_{\text{P.P}}$ and a value 6.6 times larger than the RMS value.

4.3 Typical Applications

4.3.1 LOW-PASS FILTER

[Figure 4-8](#) is a low-pass active filter using the Sallen-Key topology. It has a bandwidth of 100 kHz, which takes advantage of the MCP6071x's speed. It also has low sensitivity to component variations. This and other active filters can be easily designed using Microchip's FilterLab® design tool.

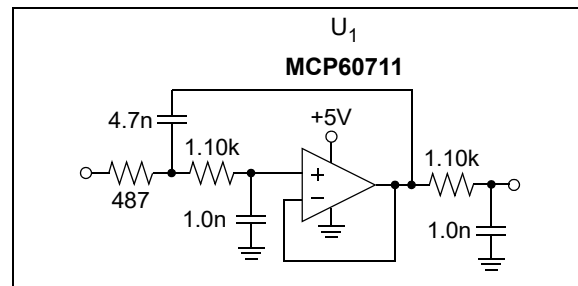


FIGURE 4-8: Sallen-Key Low-pass Filter.

4.3.2 EDGE DETECTOR

[Figure 4-9](#) shows an edge detector based on a high-pass Sallen-Key filter and a low-pass R-C filter. At low frequencies, the high-pass filter produces a gain proportional to f^2 (or the second time derivative of V_{IN}), which emphasizes the time points when there are large changes in V_{IN} 's slope. The low-pass filter limits the impact of random noise and interference.

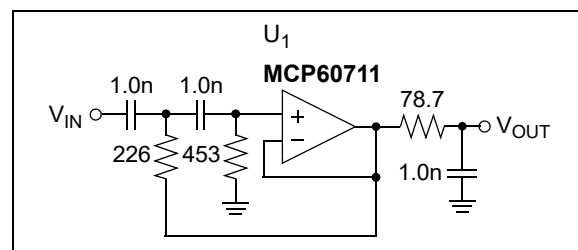


FIGURE 4-9: Edge Detector Circuit.

The high-pass filter has a second order Butterworth response, with low step response overshoot. Its cutoff frequency is 0.5 MHz, which supports detection of rise and fall times of about 0.7 μ s and longer.

The low-pass filter has a cutoff frequency of 2 MHz, which supports detection of rise and fall times of 0.7 μ s and longer.

4.3.3 PHOTO-DIODE DETECTOR

The circuit in Figure 4-10 has a photo-diode detector (D), which has parasitic capacitance C_D and produces an output current (I_D). V_{DB} biases D so that it's either in photo-voltaic mode (at 0V, like U_1 's noninverting input) or photo-conductive mode (less than 0V). Photo-voltaic mode has a linear response to light, while photo-conductive mode is faster.

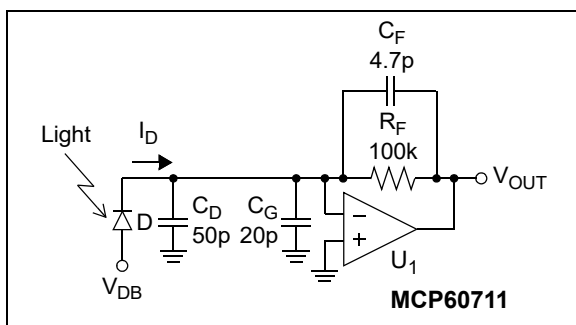


FIGURE 4-10: Photo-Diode Detector Circuit.

The op amp (U_1) provides gain. The capacitance C_G represents parasitic board capacitance plus U_1 's input capacitance (C_{CM}).

The gain resistor (R_F) converts I_D to a voltage at V_{OUT} . The combination of R_F , C_D and C_G create a noise gain zero at 22.7 kHz, which would destabilize the feedback loop without an appropriate value of C_F . C_F stabilizes the feedback loop by adding a noise gain pole at 339 kHz and sets the high frequency noise gain to 15.9 V/V.

The feedback loop's crossover frequency is U_1 's GBWP divided by the high frequency noise gain, or 629 kHz. Since this is roughly two times larger than the noise gain pole, the feedback loop is robustly stable.

The signal gain has one pole at 339 kHz, which is set by R_F and C_F (the same as the noise gain pole).

Use simulations and bench testing to obtain the design goals. Check step response overshoot for stability and output random noise for accuracy.

Other photo-voltaic detector circuits give different trade-offs. This circuit is faster than a circuit that doesn't need C_F , but requires a much faster op amp. Other implementation details can vary too.

4.3.4 PRECISION COMPARATOR

Do not use these parts as stand alone comparators. They can, however, be used to provide gain for a following comparator.

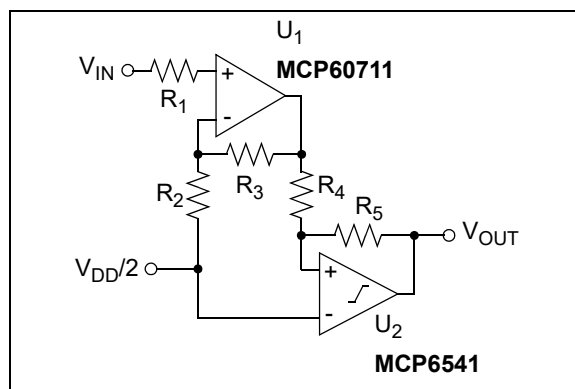


FIGURE 4-11: Precision Comparator.

5.0 DESIGN AIDS

Microchip provides the basic design aids needed for the MCP60711/1U/2/4 op amps.

5.1 Analog Demonstration Boards

Microchip offers a broad spectrum of Analog Demonstration and Evaluation Boards that are designed to help customers achieve faster time to market. For a complete listing of these boards and their corresponding user's guides and technical information, visit the Microchip web site at www.microchipdirect.com.

5.2 Application Notes

The following Microchip Analog Design Notes and Application Notes are available on the Microchip web site at www.microchip.com/appnotes and are recommended as supplemental reference resources.

- **ADN003** – “*Select the Right Operational Amplifier for your Filtering Circuits*”, DS21821
- **AN722** – “*Operational Amplifier Topologies and DC Specifications*”, DS00722
- **AN723** – “*Operational Amplifier AC Specifications and Applications*”, DS00723
- **AN884** – “*Driving Capacitive Loads With Op Amps*”, DS00884
- **AN990** – “*Analog Sensor Conditioning Circuits – An Overview*”, DS00990
- **AN1177** – “*Op Amp Precision Design: DC Errors*”, DS01177
- **AN1228** – “*Op Amp Precision Design: Random Noise*”, DS01228
- **AN1297** – “*Microchip's Op Amp SPICE Macro Models*”, DS01297
- **AN1332** – “*Current Sensing Circuit Concepts and Fundamentals*”, DS01332
- **AN1494** – “*Using MCP6491 Op Amps for Photo-detection Applications*”, DS01494

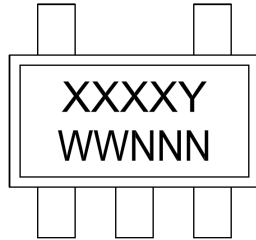
These applications notes and others are listed in the design guide:

- “*Signal Chain Design Guide*”, DS21825

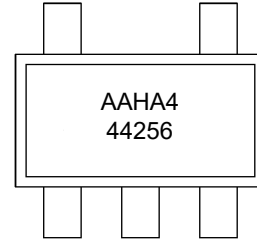
6.0 PACKAGE INFORMATION

6.1 Package Marking Information

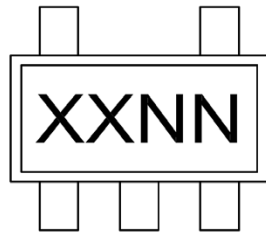
5 Lead SOT-23 (MCP60711)



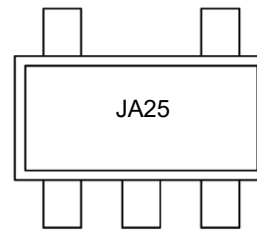
Example:



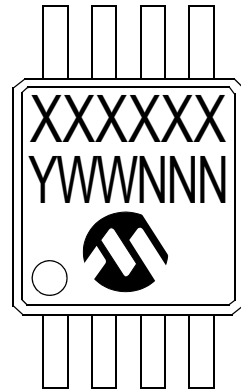
5 Lead SC70 (MCP60711U)



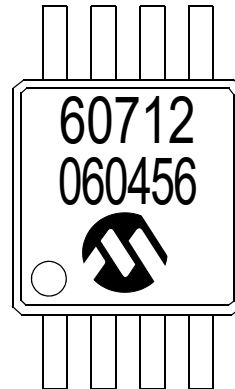
Example:



8-Lead MSOP (MCP60712)



Example:



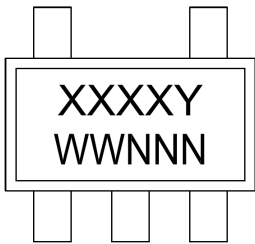
Legend:	XX...X	Customer-specific information
	Y	Year code (last digit of calendar year)
	YY	Year code (last 2 digits of calendar year)
	WW	Week code (week of January 1 is week '01')
	NNN	Alphanumeric traceability code
		Pb-free JEDEC designator for Matte Tin (Sn)
		This package is Pb-free. The Pb-free JEDEC designator can be found on the outer packaging for this package.

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for customer-specific information.

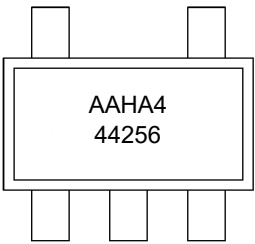
MCP60711/1U/2/4

6.2 Package Marking Information

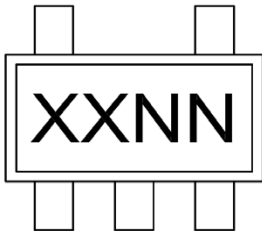
5 Lead SOT-23 (MCP60711)



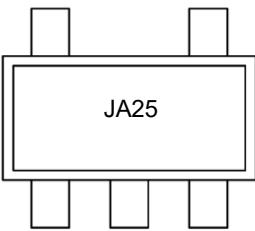
Example:



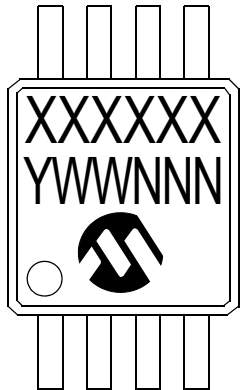
5 Lead SC70 (MCP60711U)



Example:



8-Lead MSOP (MCP60712)



Example:

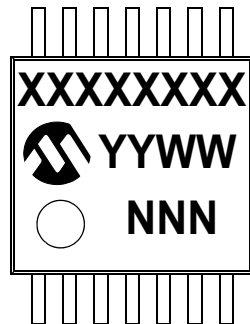


Legend:	XX...X	Customer-specific information
	Y	Year code (last digit of calendar year)
	YY	Year code (last 2 digits of calendar year)
	WW	Week code (week of January 1 is week '01')
	NNN	Alphanumeric traceability code
	(e3)	Pb-free JEDEC designator for Matte Tin (Sn)
	*e3	This package is Pb-free. The Pb-free JEDEC designator (e3) can be found on the outer packaging for this package.

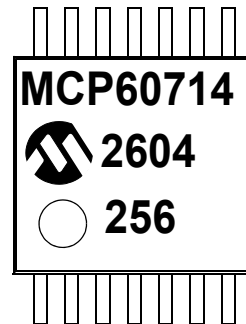
Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for customer-specific information.

Package Marking Information (Continued)

14-Lead TSSOP (MCP60714)



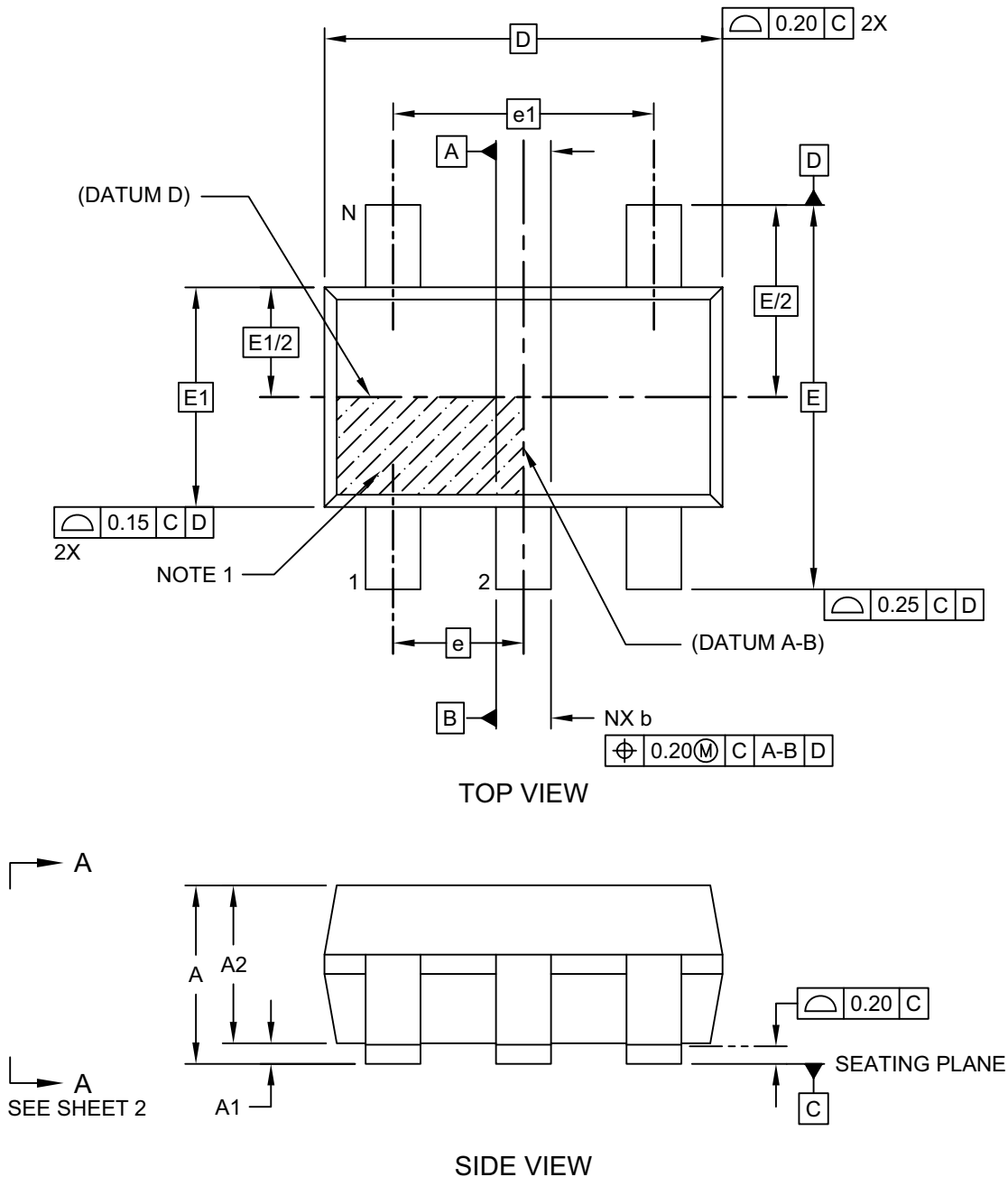
Example:



MCP60711/1U/2/4

5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

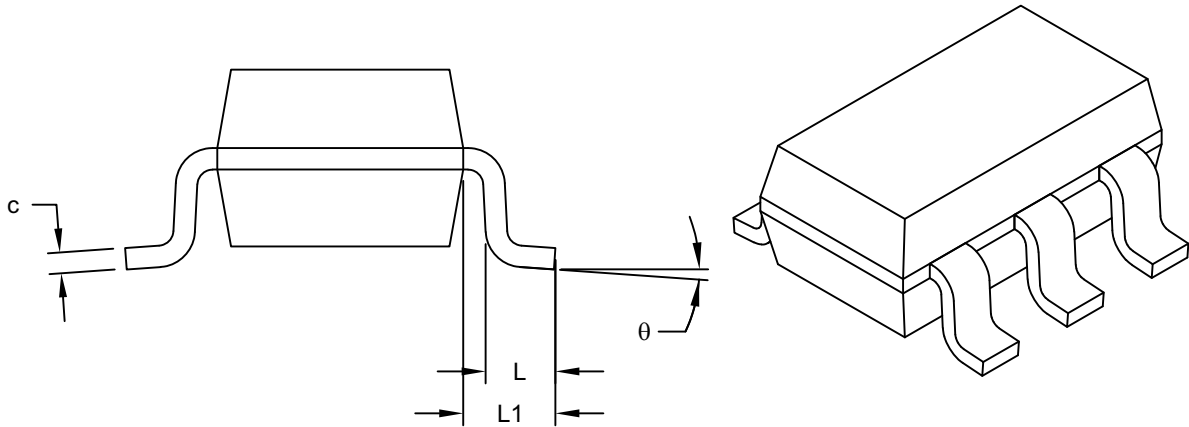
Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Microchip Technology Drawing C04-091-OT Rev H Sheet 1 of 2

5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



VIEW A-A
SHEET 1

Dimension Limits	Units	MILLIMETERS		
		MIN	NOM	MAX
Number of Pins	N	5		
Pitch	e	0.95 BSC		
Outside lead pitch	e1	1.90 BSC		
Overall Height	A	0.90	-	1.45
Molded Package Thickness	A2	0.89	-	1.30
Standoff	A1	-	-	0.15
Overall Width	E	2.80 BSC		
Molded Package Width	E1	1.60 BSC		
Overall Length	D	2.90 BSC		
Foot Length	L	0.30	-	0.60
Footprint	L1	0.60 REF		
Foot Angle	θ	0°	-	10°
Lead Thickness	c	0.08	-	0.26
Lead Width	b	0.20	-	0.51

Notes:

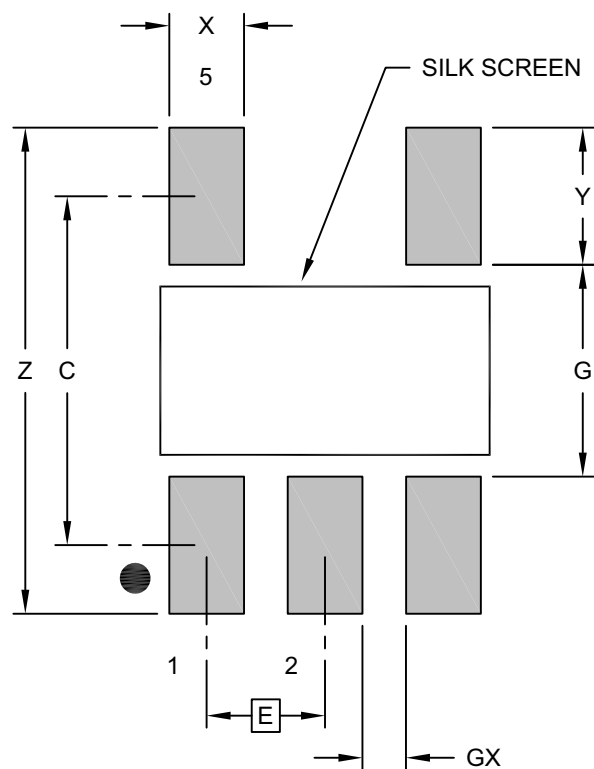
- Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.25mm per side.
- Dimensioning and tolerancing per ASME Y14.5M
 - BSC: Basic Dimension. Theoretically exact value shown without tolerances.
 - REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-091-OT Rev H Sheet 2 of 2

MCP60711/1U/2/4

5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E	0.95 BSC		
Contact Pad Spacing	C		2.80	
Contact Pad Width (X5)	X			0.60
Contact Pad Length (X5)	Y			1.10
Distance Between Pads	G	1.70		
Distance Between Pads	GX	0.35		
Overall Width	Z			3.90

Notes:

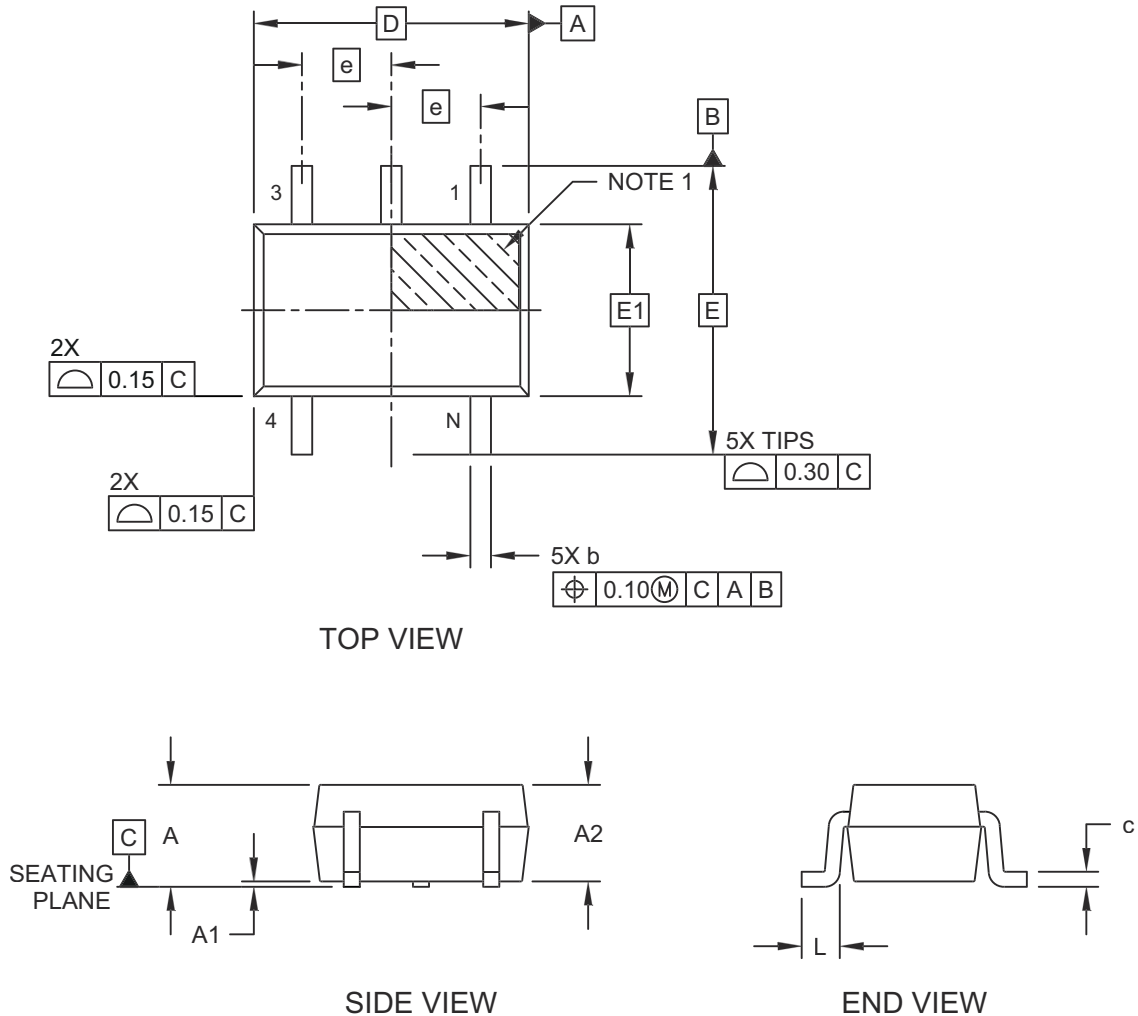
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2091-OT Rev H

5-Lead Plastic Small Outline Transistor (LTY) [SC70]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>

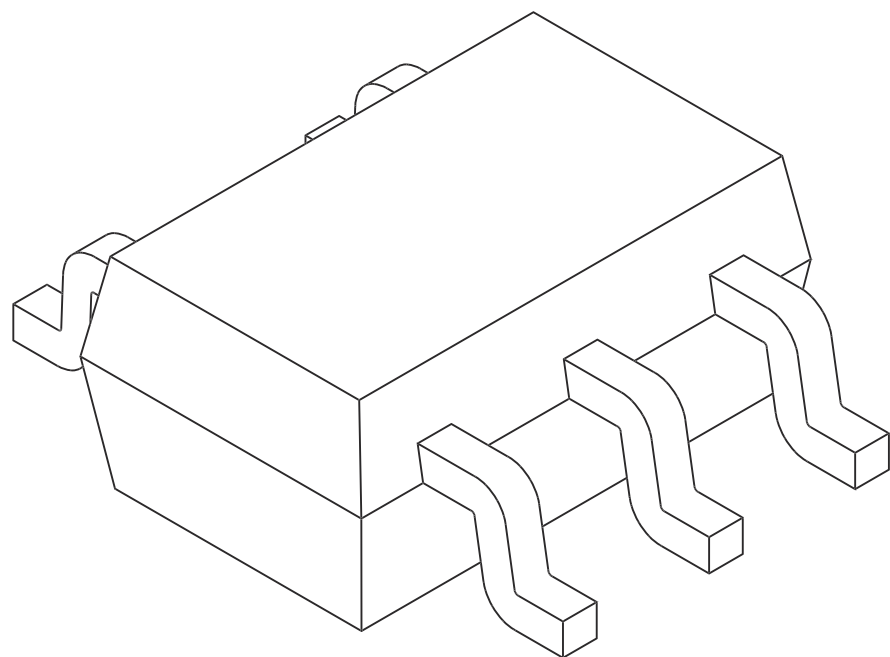


Microchip Technology Drawing C04-00061-LTY Rev F Sheet 1 of 2

MCP60711/1U/2/4

5-Lead Plastic Small Outline Transistor (LTY) [SC70]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packages>



Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Number of Pins	N	5		
Pitch	e	0.65 BSC		
Overall Height	A	0.80	-	1.10
Standoff	A1	0.00	-	0.10
Molded Package Thickness	A2	0.80	-	1.00
Overall Length	D	2.00 BSC		
Overall Width	E	2.10 BSC		
Molded Package Width	E1	1.25 BSC		
Terminal Width	b	0.15	-	0.40
Terminal Length	L	0.10	0.20	0.46
Lead Thickness	c	0.08	-	0.26

Notes:

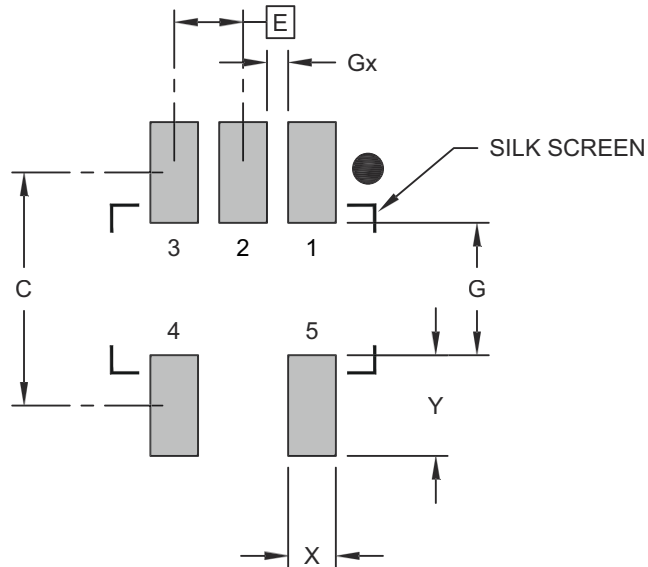
- 1. The Pin 1 visual index feature may vary, but it must be located within the hatched area.
- 2. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- 3. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. The theoretically exact value is shown without tolerances.

REF: Reference Dimension, usually without tolerance, is for information purposes only.

5-Lead Plastic Small Outline Transistor (LTY) [SC70]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

	Units	MILLIMETERS		
		MIN	NOM	MAX
Contact Pitch	E		0.65 BSC	
Contact Pad Spacing	C		2.20	
Contact Pad Width	X			0.45
Contact Pad Length	Y			0.95
Distance Between Pads	G	1.25		
Distance Between Pads	Gx	0.20		

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

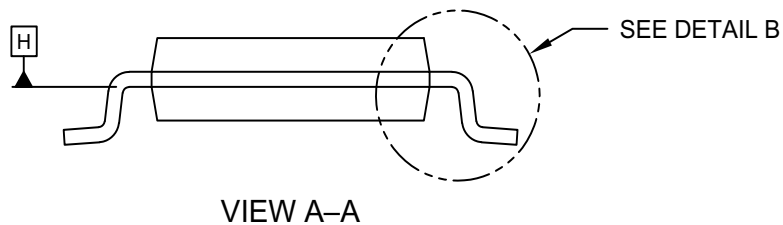
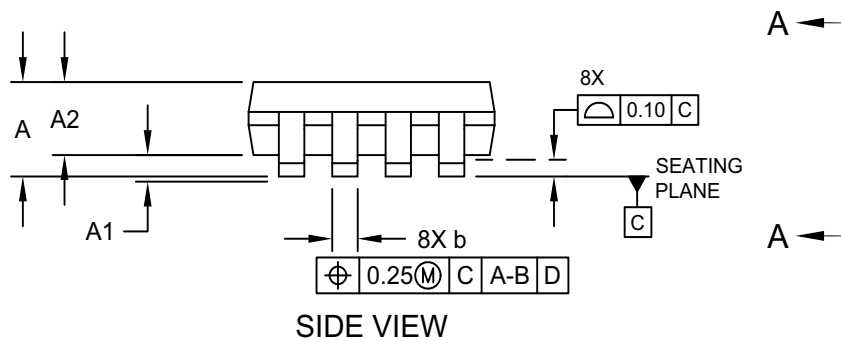
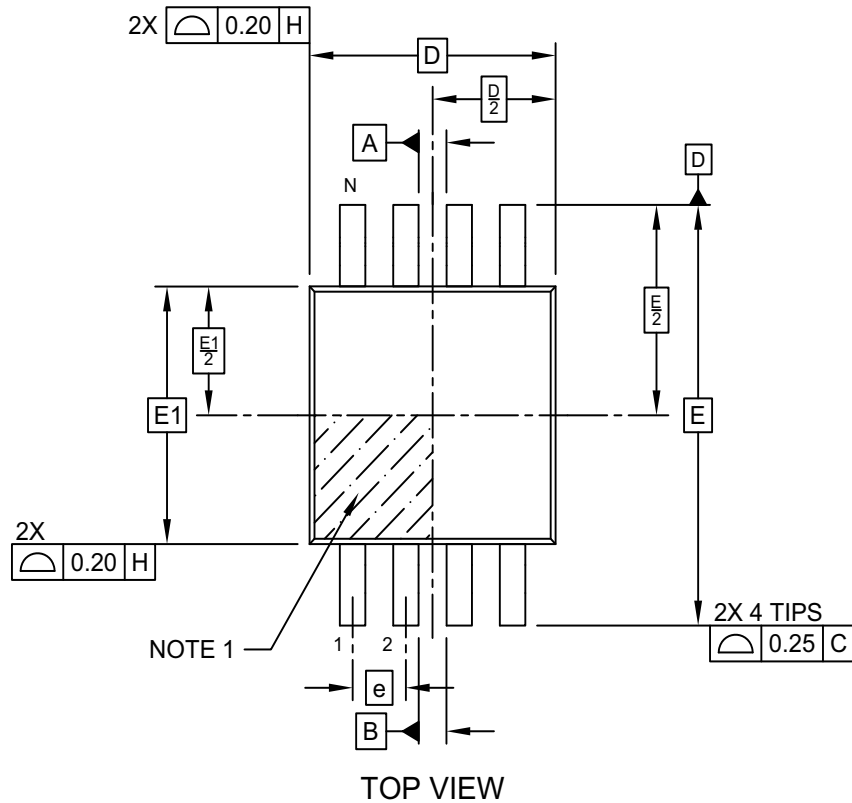
BSC: Basic Dimension. The theoretically exact value is shown without tolerances.

Microchip Technology Drawing No. C04-02061-LTY Rev F

MCP60711/1U/2/4

8-Lead Plastic Micro Small Outline Package (A3X) - 3x3 mm Body [MSOP]

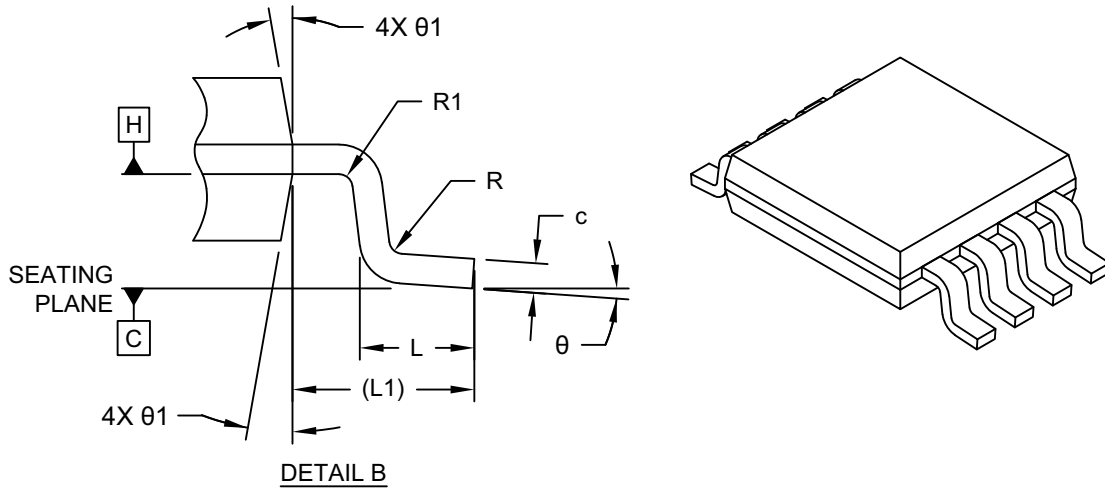
Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



Microchip Technology Drawing C04-111-A3X Rev F Sheet 1 of 2

8-Lead Plastic Micro Small Outline Package (A3X) - 3x3 mm Body [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



		Units	MILLIMETERS		
Dimension Limits			MIN	NOM	MAX
Number of Terminals	N		8		
Pitch	e		0.65 BSC		
Overall Height	A		–	–	1.10
Standoff	A1		0.00	–	0.15
Molded Package Thickness	A2		0.75	0.85	0.95
Overall Length	D		3.00 BSC		
Overall Width	E		4.90 BSC		
Molded Package Width	E1		3.00 BSC		
Terminal Width	b		0.22	–	0.40
Terminal Thickness	c		0.08	–	0.23
Terminal Length	L		0.40	0.60	0.80
Footprint	L1		0.95 REF		
Lead Bend Radius	R		0.07	–	–
Lead Bend Radius	R1		0.07	–	–
Foot Angle	θ		0°	–	8°
Mold Draft Angle	θ1		5°	–	15°

Notes:

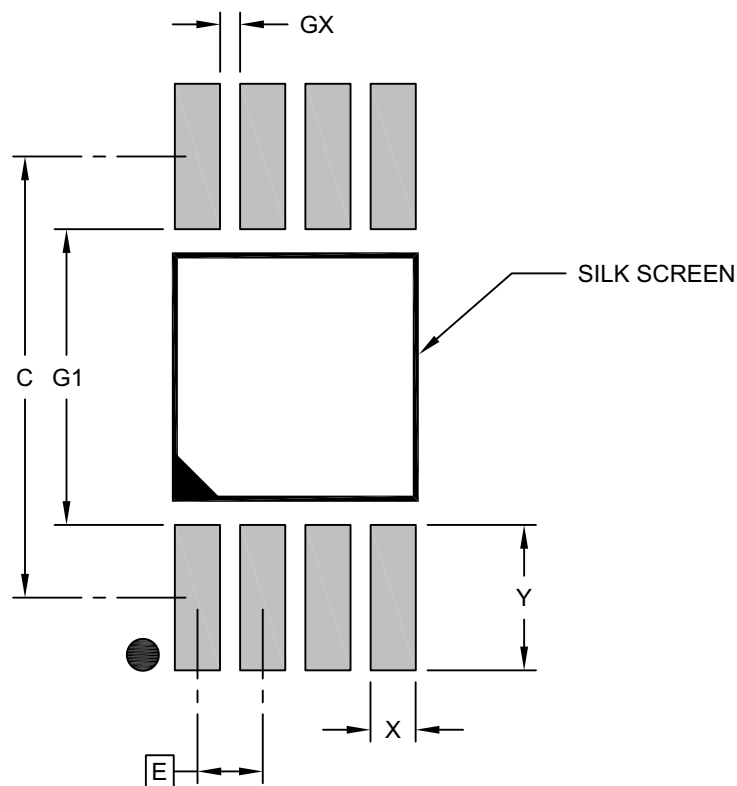
- Pin 1 visual index feature may vary, but must be located within the hatched area.
- Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- Dimensioning and tolerancing per ASME Y14.5M
BSC: Basic Dimension. Theoretically exact value shown without tolerances.
REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-111-A3X Rev F Sheet 2 of 2

MCP60711/1U/2/4

8-Lead Plastic Micro Small Outline Package (A3X) - 3x3 mm Body [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E	0.65 BSC		
Contact Pad Spacing	C		4.40	
Contact Pad Width (X8)	X			0.45
Contact Pad Length (X8)	Y			1.45
Contact Pad to Contact Pad (X4)	G1	2.95		
Contact Pad to Contact Pad (X6)	GX	0.20		

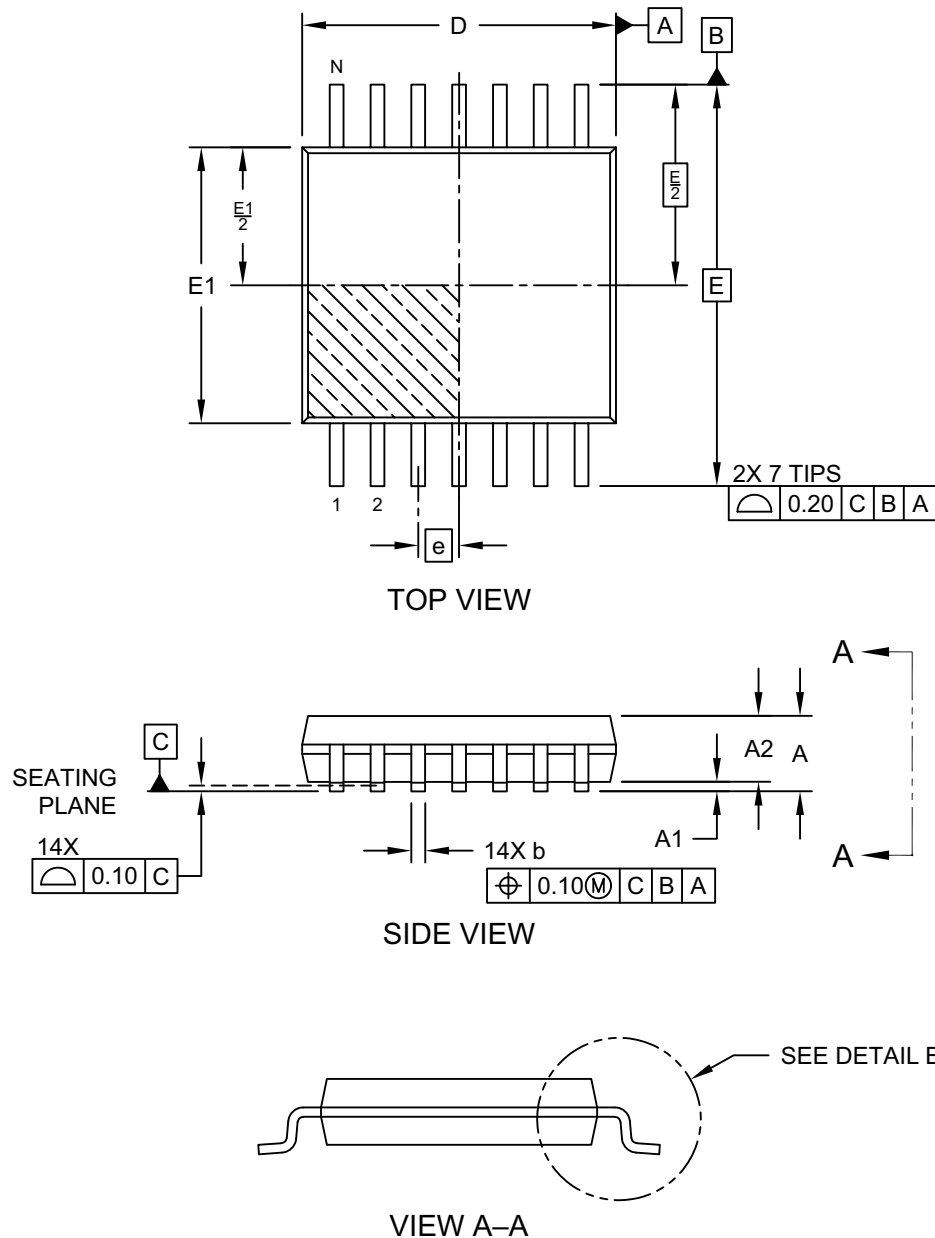
Notes:

- 1. Dimensioning and tolerancing per ASME Y14.5M
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-2111-A3X Rev F

14-Lead Plastic Thin Shrink Small Outline Package [D4X] - 4.4 mm Body [TSSOP]

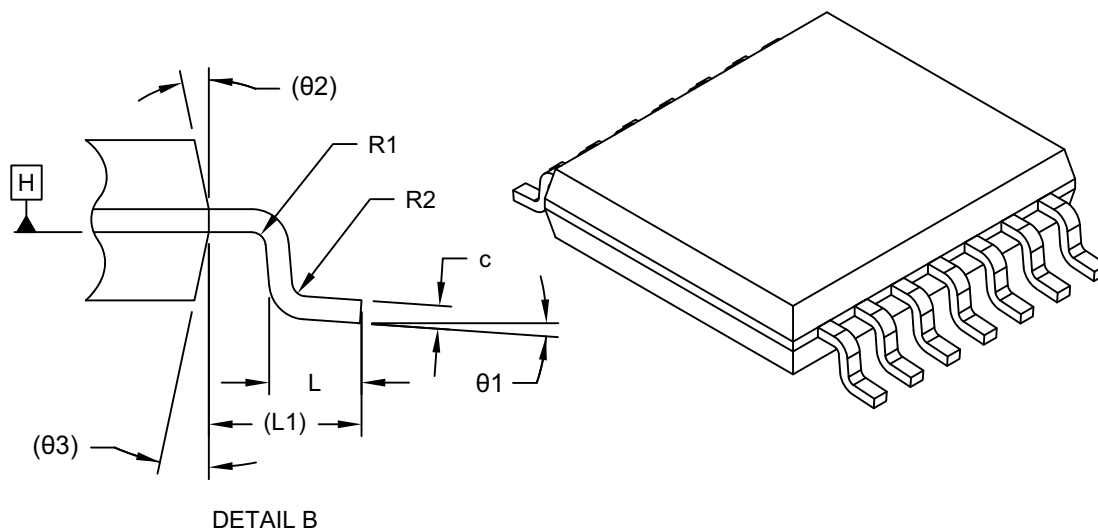
Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



MCP60711/1U/2/4

14-Lead Plastic Thin Shrink Small Outline Package [D4X] - 4.4 mm Body [TSSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



		Units	MILLIMETERS		
Dimension Limits			MIN	NOM	MAX
Number of Terminals	N		14		
Pitch	e		0.65 BSC		
Overall Height	A	–	–	–	1.20
Standoff	A1	0.05	–	–	0.15
Molded Package Thickness	A2	0.80	1.00	–	1.05
Overall Length	D	4.90	5.00	–	5.10
Overall Width	E		6.40 BSC		
Molded Package Width	E1	4.30	4.40	–	4.50
Terminal Width	b	0.19	–	–	0.30
Terminal Thickness	c	0.09	–	–	0.20
Terminal Length	L	0.45	0.60	–	0.75
Footprint	L1		1.00 REF		
Lead Bend Radius	R1	0.09	–	–	–
Lead Bend Radius	R2	0.09	–	–	–
Foot Angle	θ1	0°	–	–	8°
Mold Draft Angle	θ2	–	12° REF	–	–
Mold Draft Angle	θ3	–	12° REF	–	–

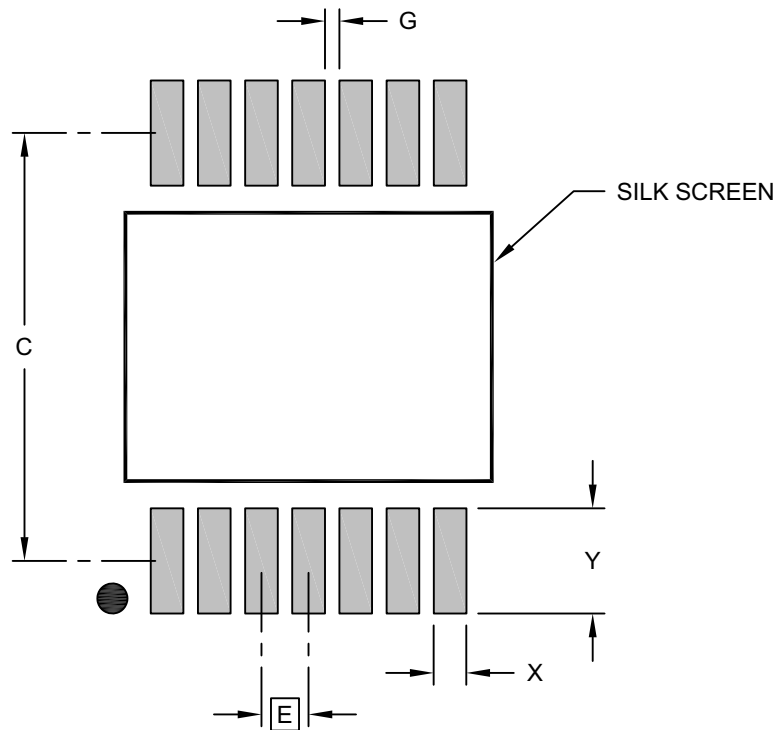
Notes:

- Pin 1 visual index feature may vary, but must be located within the hatched area.
- Dimensioning and tolerancing per ASME Y14.5M
BSC: Basic Dimension. Theoretically exact value shown without tolerances.
REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-087-D4X Rev F Sheet 2 of 2

14-Lead Plastic Thin Shrink Small Outline Package [D4X] – 4.4 mm Body [TSSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at <http://www.microchip.com/packaging>



RECOMMENDED LAND PATTERN

Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E	0.65 BSC		
Contact Pad Spacing	C		5.90	
Contact Pad Width (X14)	X			0.45
Contact Pad Length (X14)	Y			1.45
Contact Pad to Contact Pad (X12)	G	0.20		

Notes:

- Dimensioning and tolerancing per ASME Y14.5M
BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-2087-D4X Rev F

APPENDIX A: REVISION HISTORY

Revision C (June 2026)

- Added the following:
 - Dual and quad op amps
 - Automotive parts
- Removed the op amp with shutdown
- Updated the following:
 - Input current specs (I_B and I_{OS})
 - Specs related to the Input Offset Voltage
 - Spec conditions in [Table 1-2](#) and [Section 1.3, Timing Diagrams](#)
 - [Section 2.0, Typical Performance Curves](#)
 - [Section 4.0, Application Information](#)
- Minor corrections and editorial updates

Revision B (January 2026)

- The Revision DS20006870B of this data sheet was not issued.

Revision A (February 2024)

- Original release of this document.

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

<u>PART NO.</u>		<u>X⁽¹⁾</u>	<u>-X</u>	<u>/XX</u>	<u>XXX⁽²⁾</u>	Examples:	
Device	Tape and Reel Option	Temperature Range	Package	Class		a)	MCP60711T-E/OT: Tape and Reel, Extended temperature, 5LD SOT-23
						b)	MCP60711UT-E/LTY: Tape and Reel, Extended temperature, 5LD SC70
						c)	MCP60712T-E/MS: Tape and Reel, Extended temperature, 8LD MSOP
						d)	MCP60714T-E/ST: Tape and Reel, Extended temperature, 14LD TSSOP
Device: MCP60711T Single Op Amp (Tape and Reel) MCP60711UT Single Op Amp (Tape and Reel) MCP60712T Dual Op Amp (Tape and Reel) MCP60714T Quad Op Amp (Tape and Reel)						Note 1: Tape and Reel identifier only appears in the catalog part number description. This identifier is used for ordering purposes and is not printed on the device package. Check with your Microchip Sales Office for package availability with the Tape and Reel option. 2: Automotive parts are AEC-Q100 qualified, Grade 1.	
Temperature Range: E = -40°C to +125°C							
Package: LTY = Plastic Package (SC70), 5-lead * OT = Plastic Small Outline Transistor (SOT-23), 5-lead MS = Plastic MSOP, 8-lead ST = Plastic Thin Shrink Small Outline (4.4 mm), 14-Lead * Y = nickel palladium gold manufacturing designator.							
Class: (Blank) = Non-Automotive VAO = Automotive							

MCP60711/1U/2/4

PRODUCT IDENTIFICATION SYSTEM (AUTOMOTIVE)

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

<u>PART NO.</u>	<u>X⁽¹⁾</u>	<u>-X</u>	<u>/XX</u>	<u>XXX⁽²⁾</u>	Examples:
Device	Tape and Reel Option	Temperature Range	Package	Class	
Device: MCP60711T Single Op Amp (Tape and Reel) MCP60711UT Single Op Amp (Tape and Reel) MCP60712T Dual Op Amp (Tape and Reel) MCP60714T Quad Op Amp (Tape and Reel) Temperature Range: E = -40°C to +125°C Package: LTY = Plastic Package (SC70), 5-Lead * OT = Plastic Small Outline Transistor (SOT-23), 5-Lead MS = Plastic MSOP, 8-Lead ST = Plastic Thin Shrink Small Outline (4.4 mm), 14-Lead * Y = nickel palladium gold manufacturing designator. Class (Blank) = Non-Automotive VAO = Automotive					a) MCP60711T-E/OTVAO: Tape and Reel, Automotive Extended temperature, 5LD SOT-23 b) MCP60711UT-E/LTYVAO: Tape and Reel, Automotive Extended temperature, 5LD SC70 c) MCP60712T-E/MSVAO: Tape and Reel, Automotive Extended temperature, 8LD MSOP d) MCP60714T-E/STVAO: Tape and Reel, Automotive Extended temperature, 14LD TSSOP Note 1: Tape and Reel identifier only appears in the catalog part number description. This identifier is used for ordering purposes and is not printed on the device package. Check with your Microchip Sales Office for package availability with the Tape and Reel option. 2: Automotive parts are AEC-Q100 qualified, Grade 1

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